

Reduction, Creep Deformation and the Evolution of Residual Stresses in SOFC Anodes

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Thomas R. Watkins

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2018 SOFC Program Review

Acknowledgments

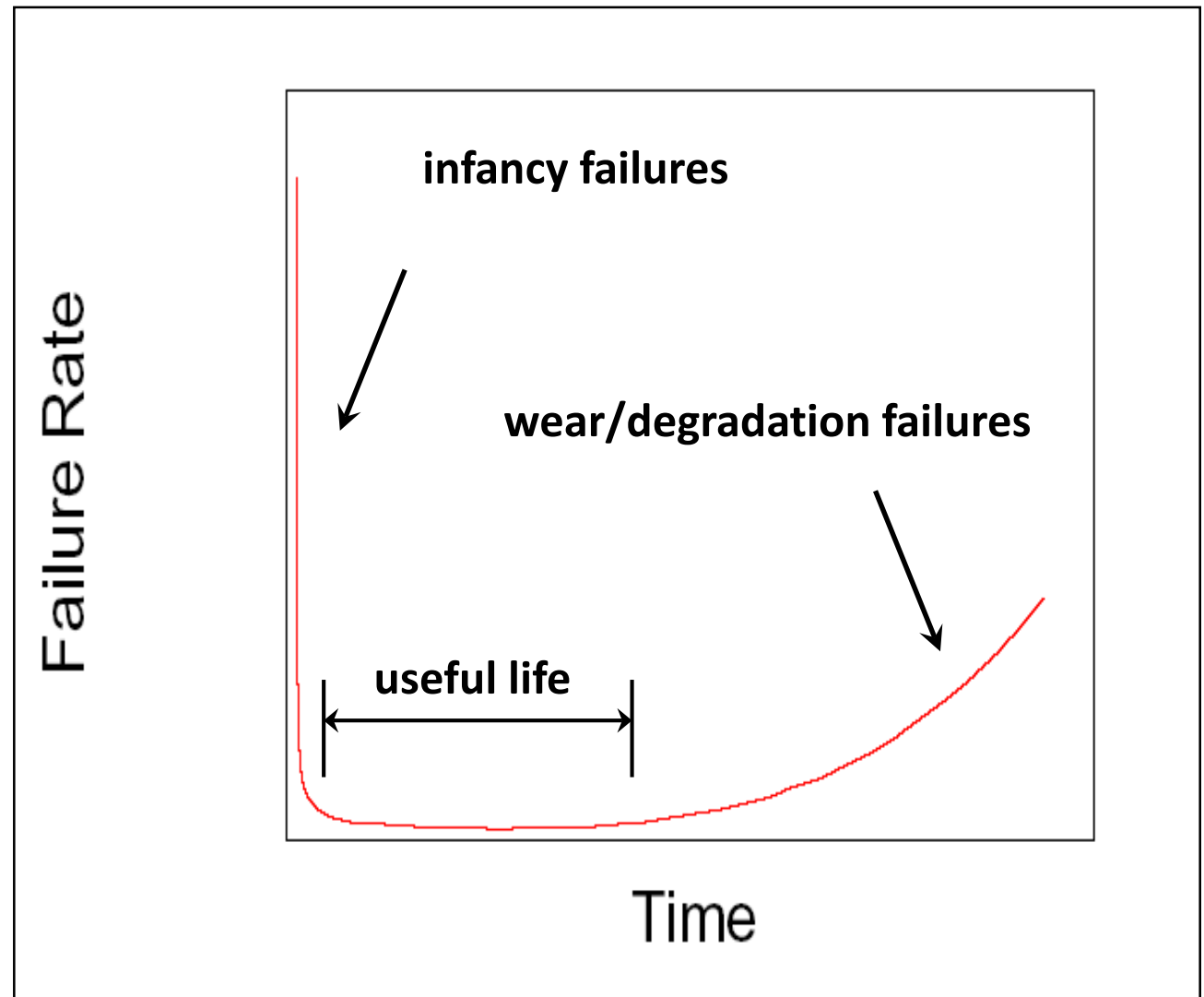
This research was sponsored by the US Department of Energy, Office of Fossil Energy, Solid Oxide Fuel Cells Core Technology Program at ORNL under Contract DEAC05-00OR22725 with UT-Battelle, LLC.

Program managers Rin N. Burke and Shailesh D. Vora.

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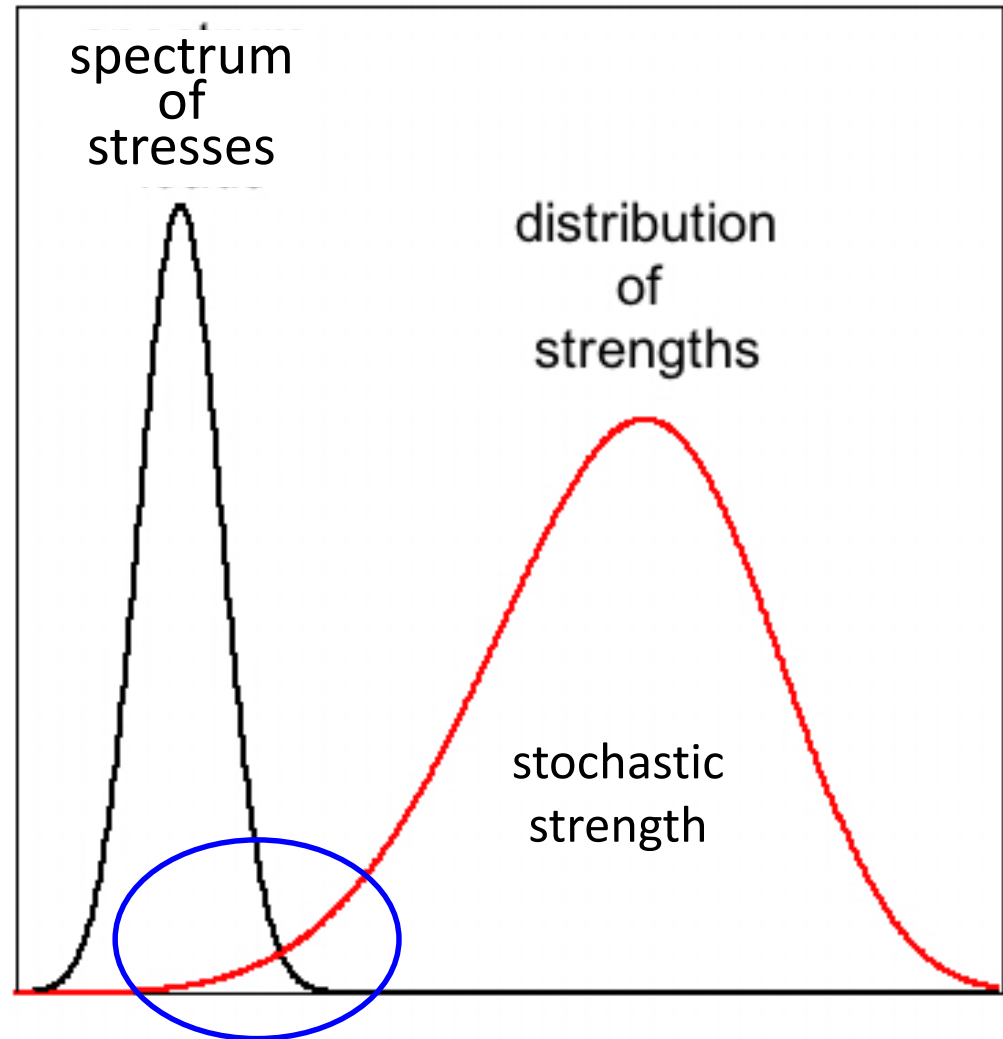
Failure, Reliability and Durability of Systems

The failure rate of complex systems can be described by the bathtub curve

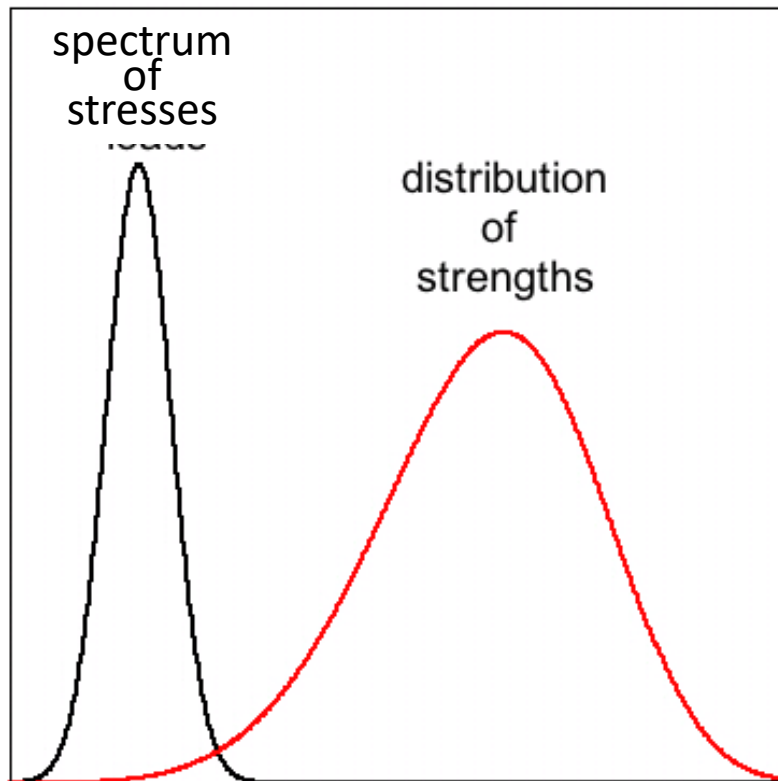


Failure, Reliability and Durability of Systems

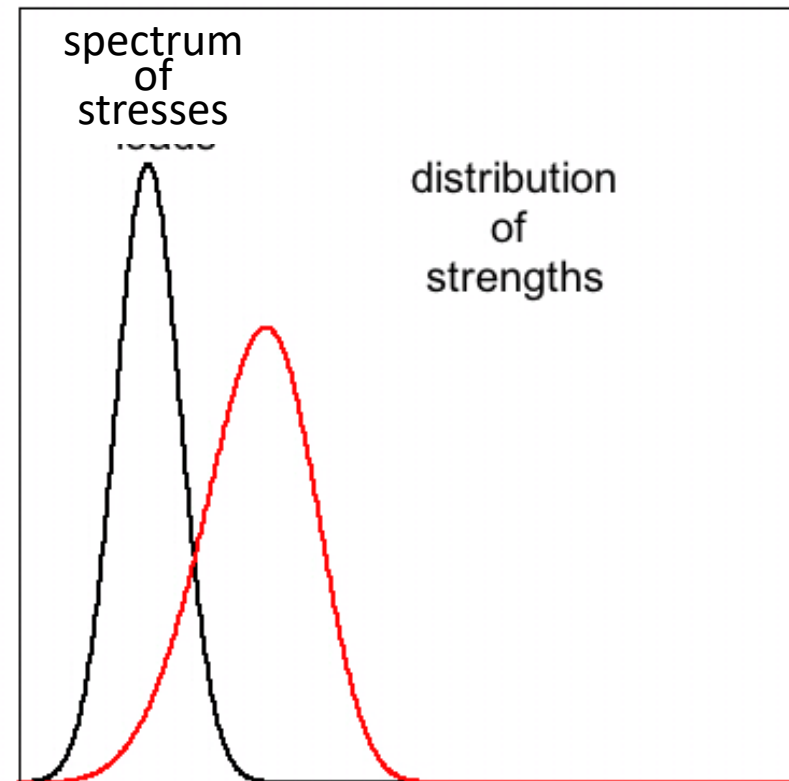
- Failure is determined by the intersection of the distributions of loads and strengths.
- The weakest elements of the population determine the reliability of the system.



Failure, Reliability and Durability of Systems

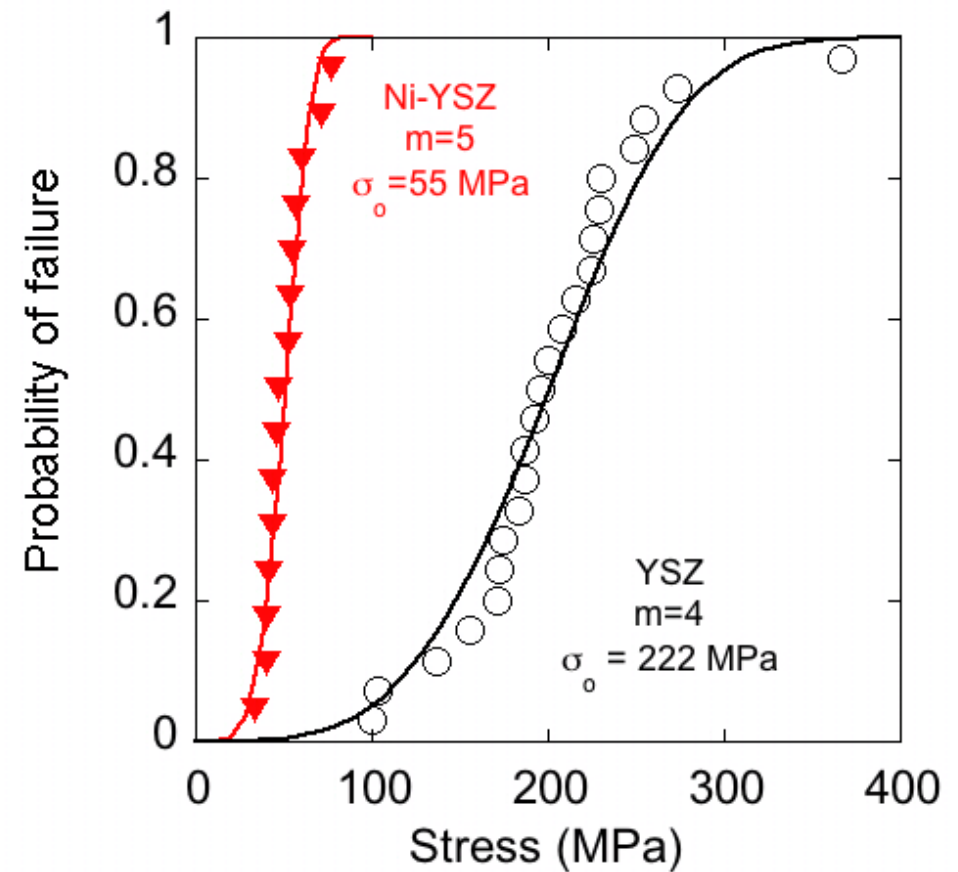
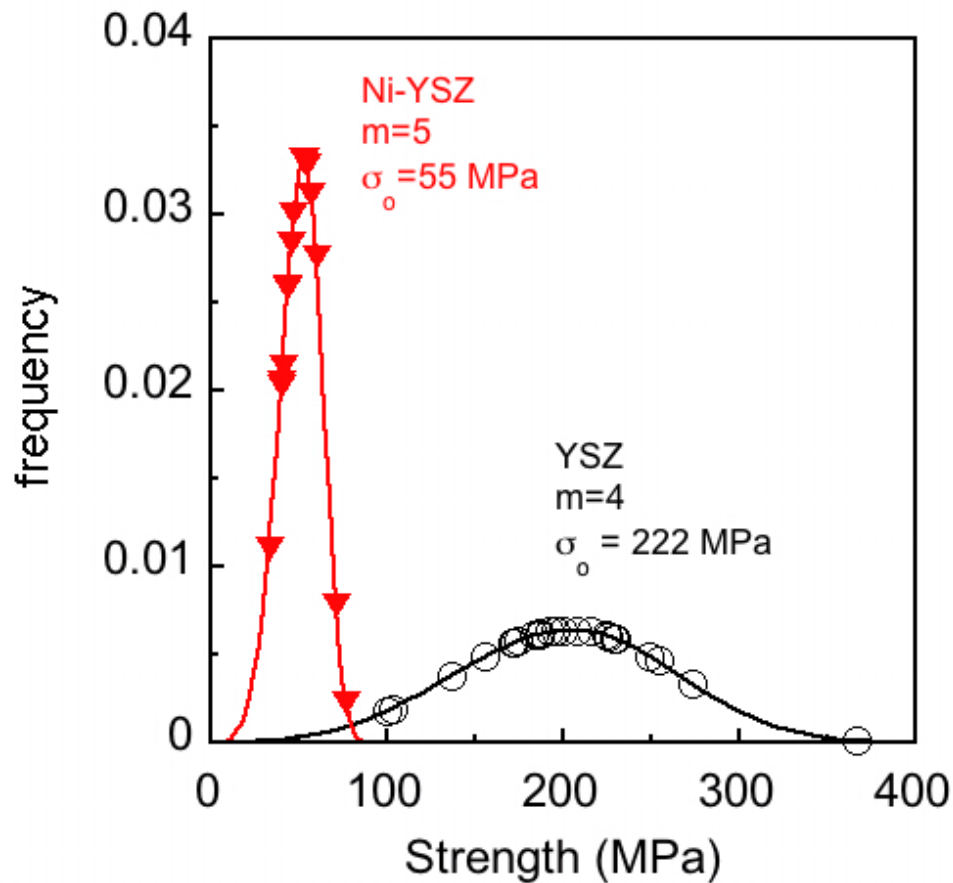


before



after

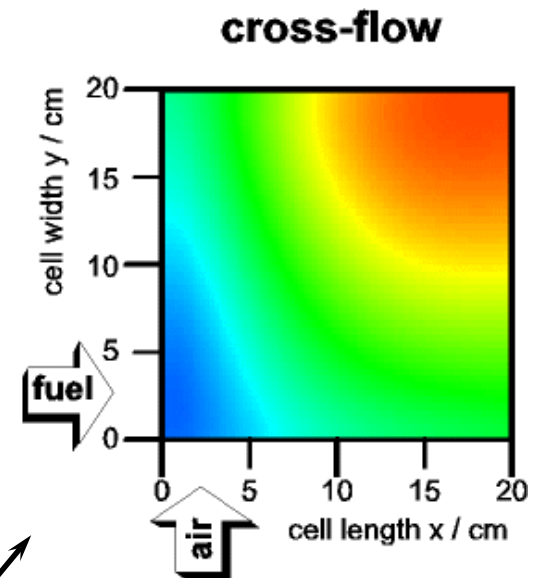
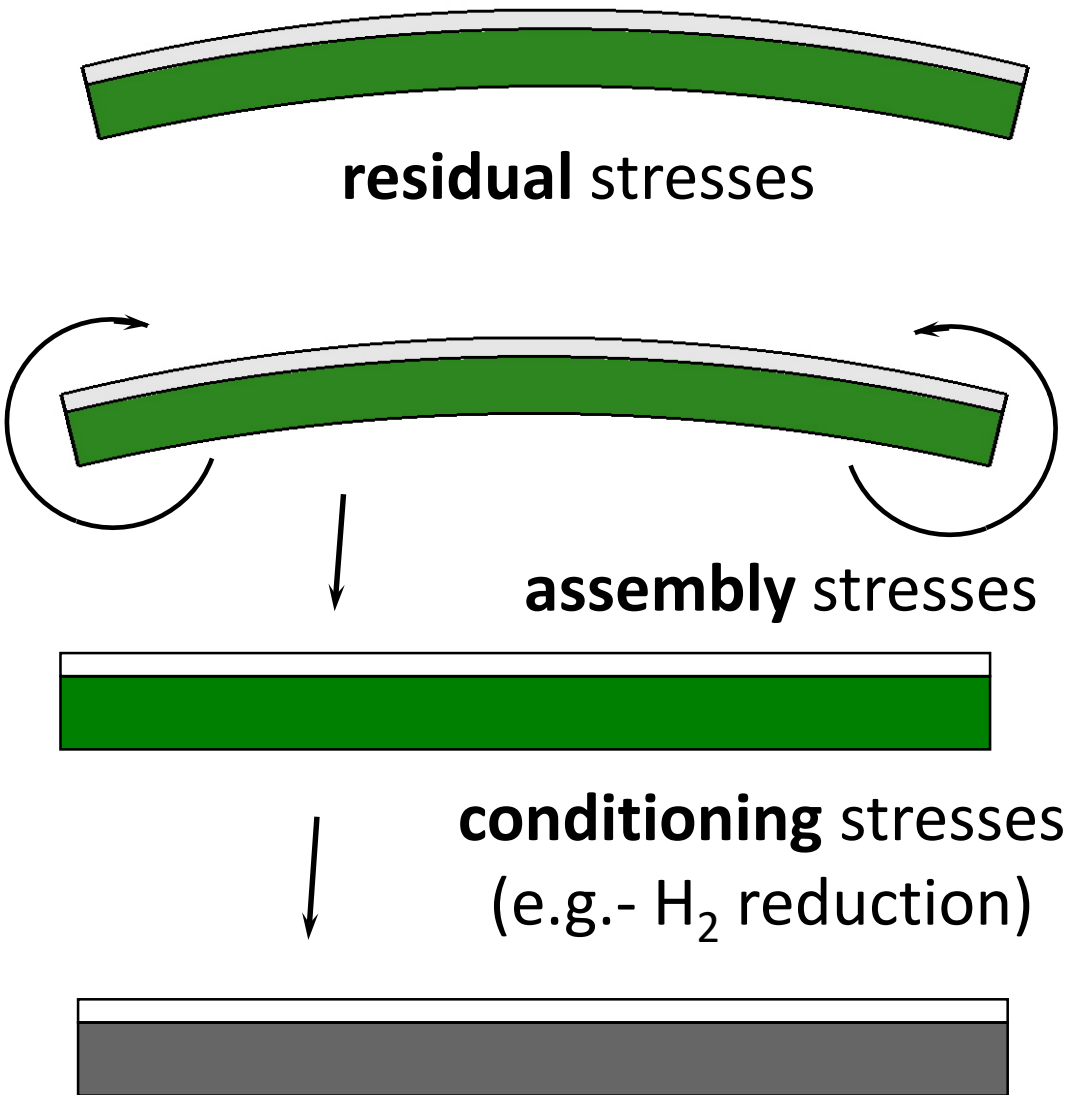
Strength of SOFC materials



Objectives

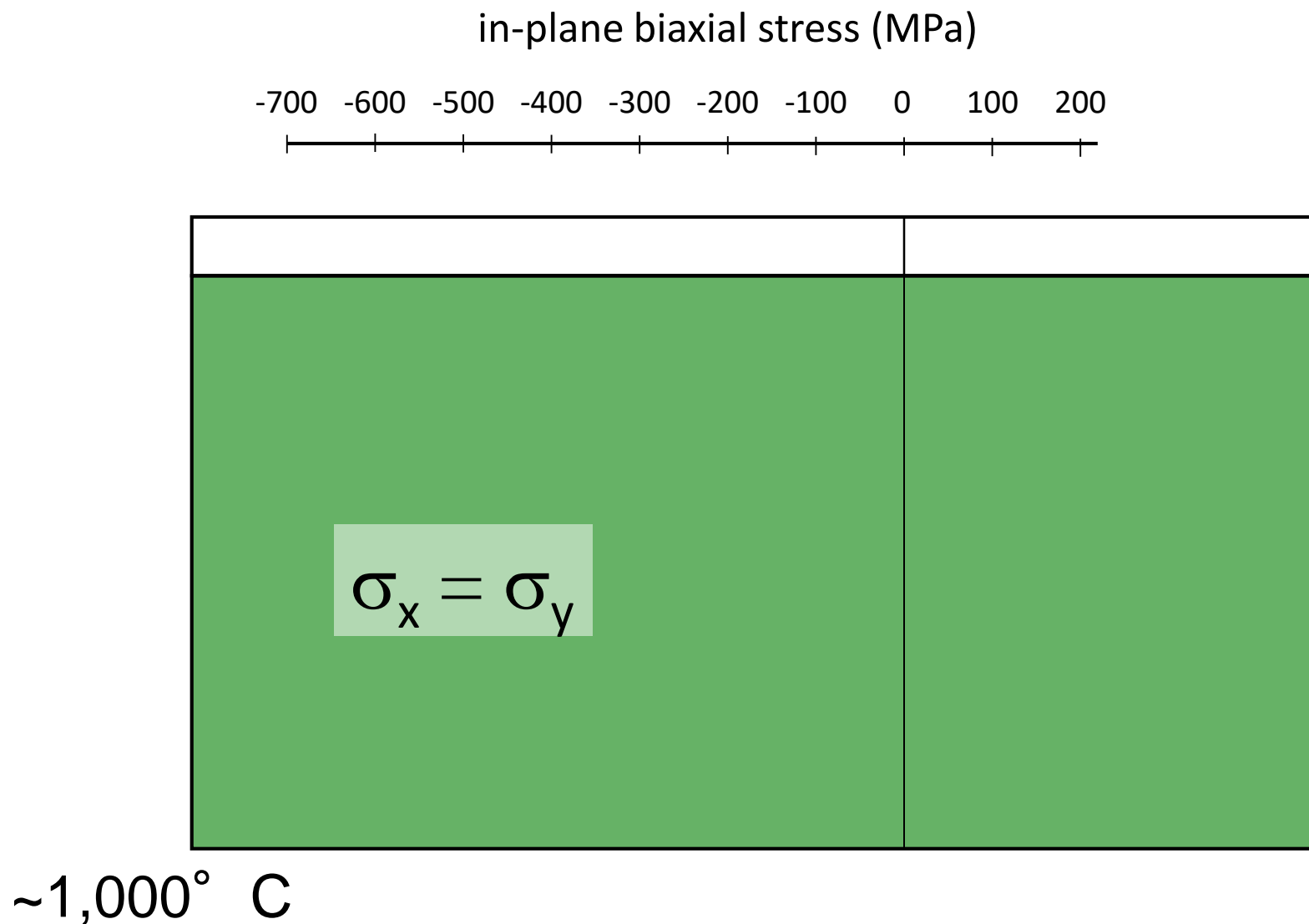
- To understand the effect of **reduction temperature** on the state of stress of solid-oxide fuel cells
- To understand the effect of **creep deformation** of anode materials on its microstructure and on the redistribution of stresses in solid-oxide fuel cells

Background

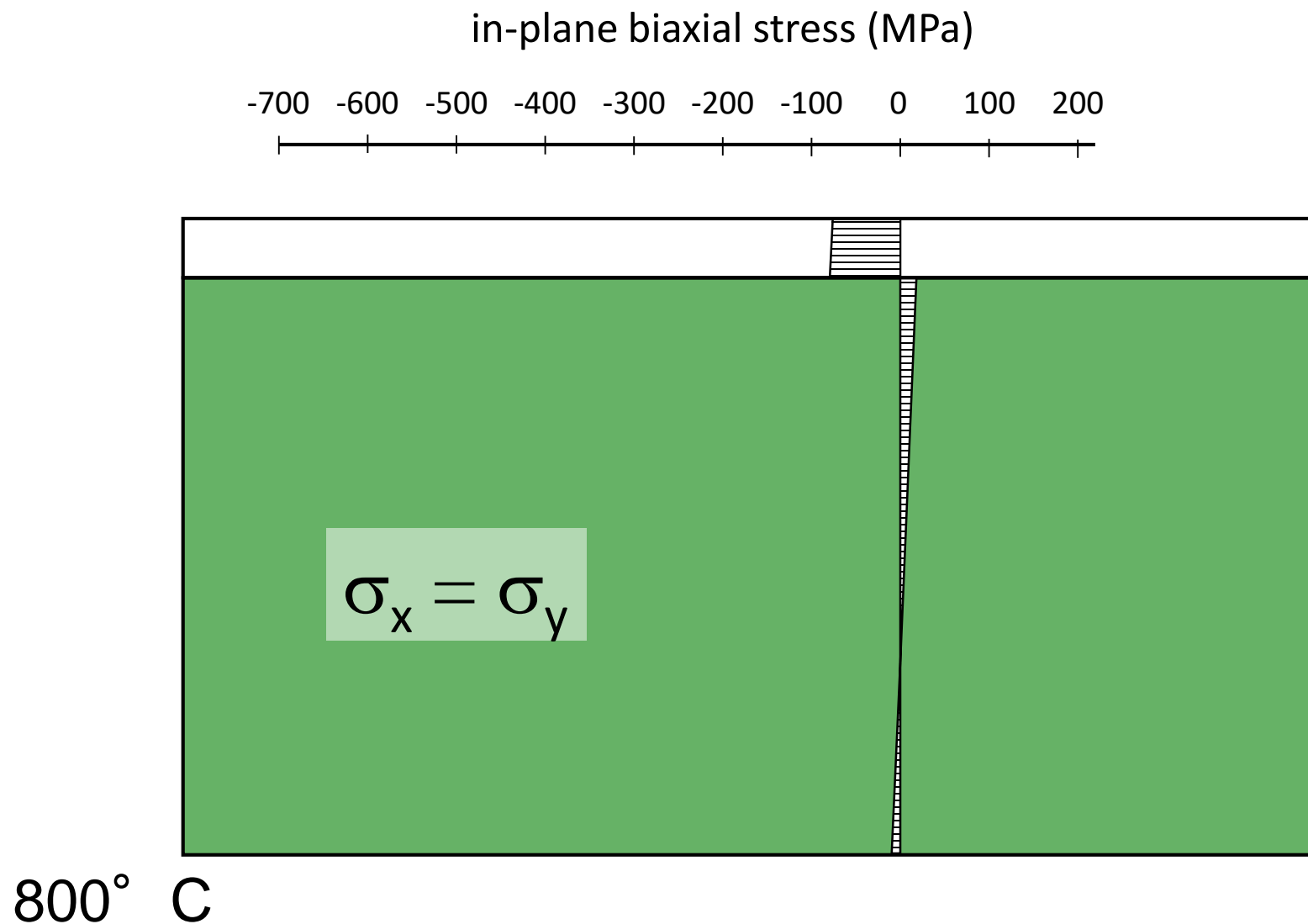


temperature gradients
and gas pressure induce
operational stresses

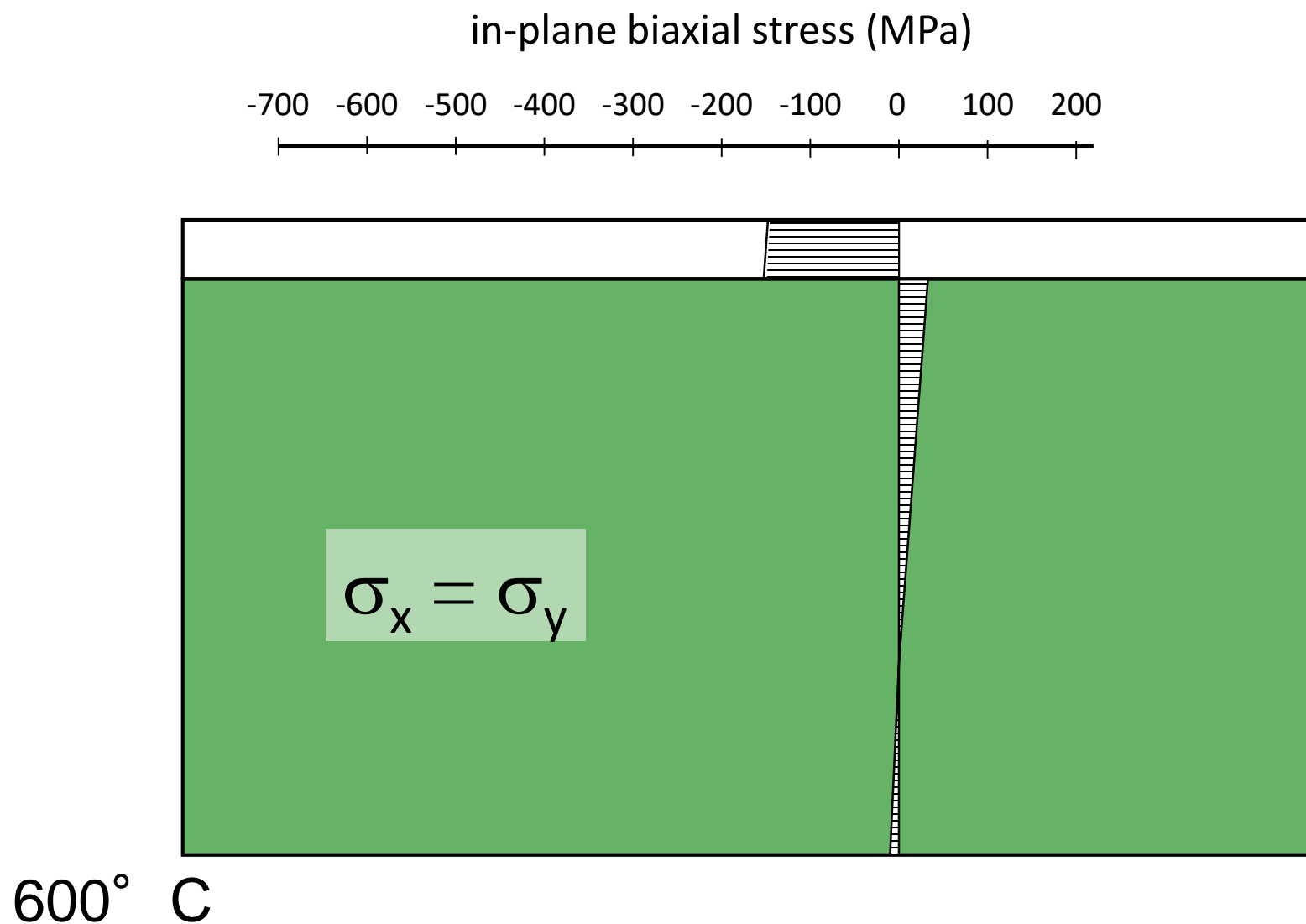
Residual Stresses in YSZ-NiO-YSZ bilayer



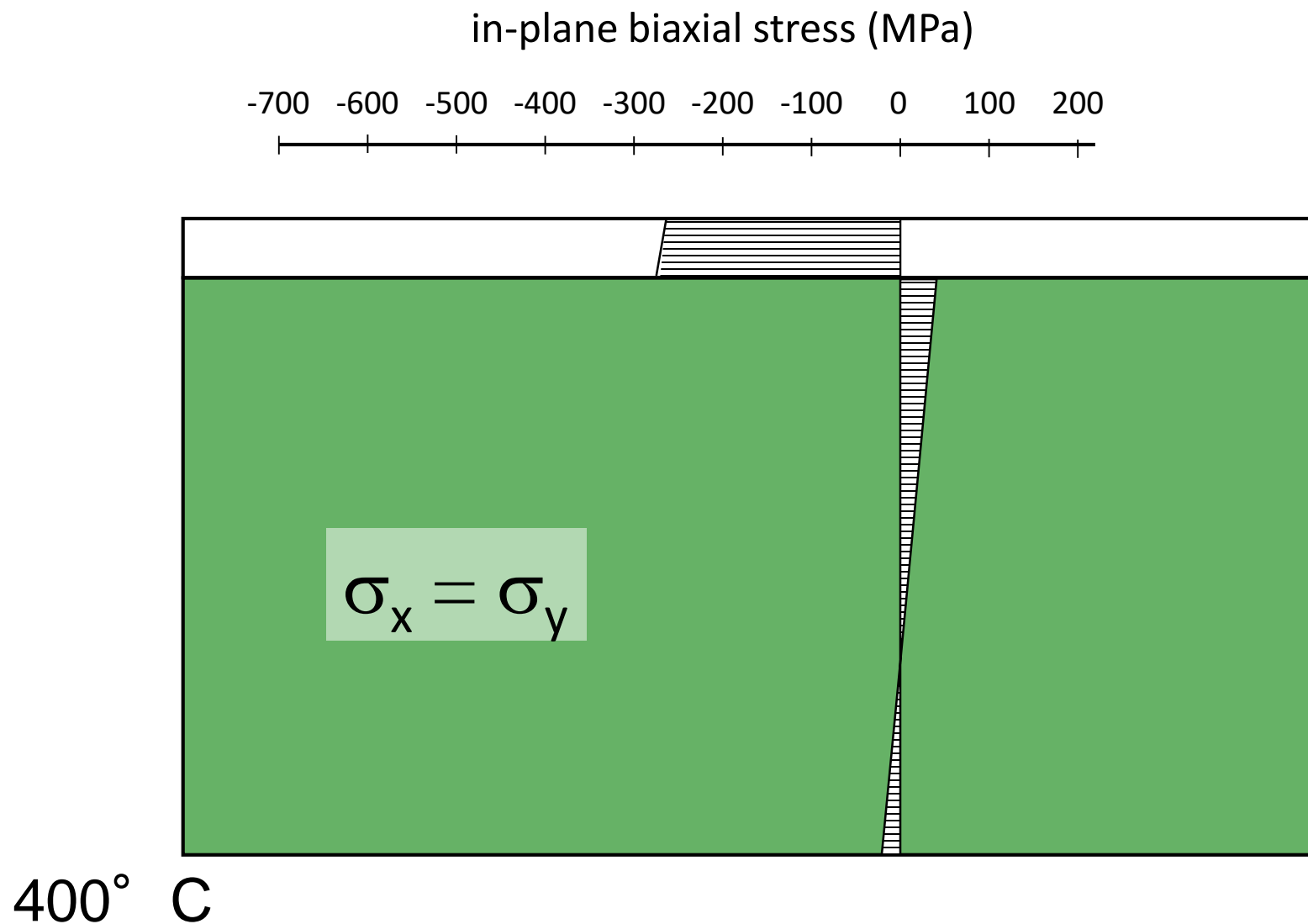
Residual Stresses in YSZ-NiO-YSZ bilayer



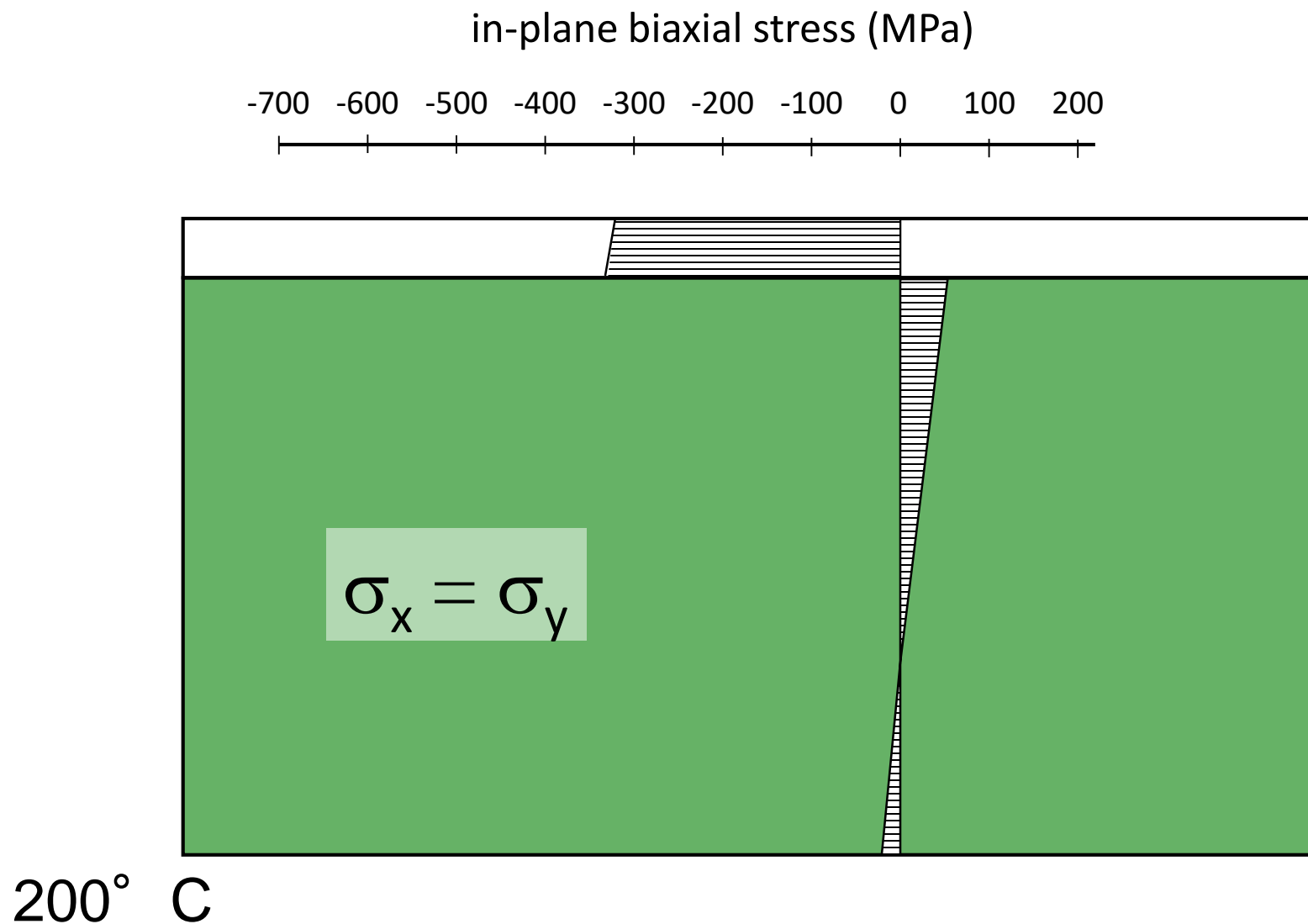
Residual Stresses in YSZ-NiO-YSZ bilayer



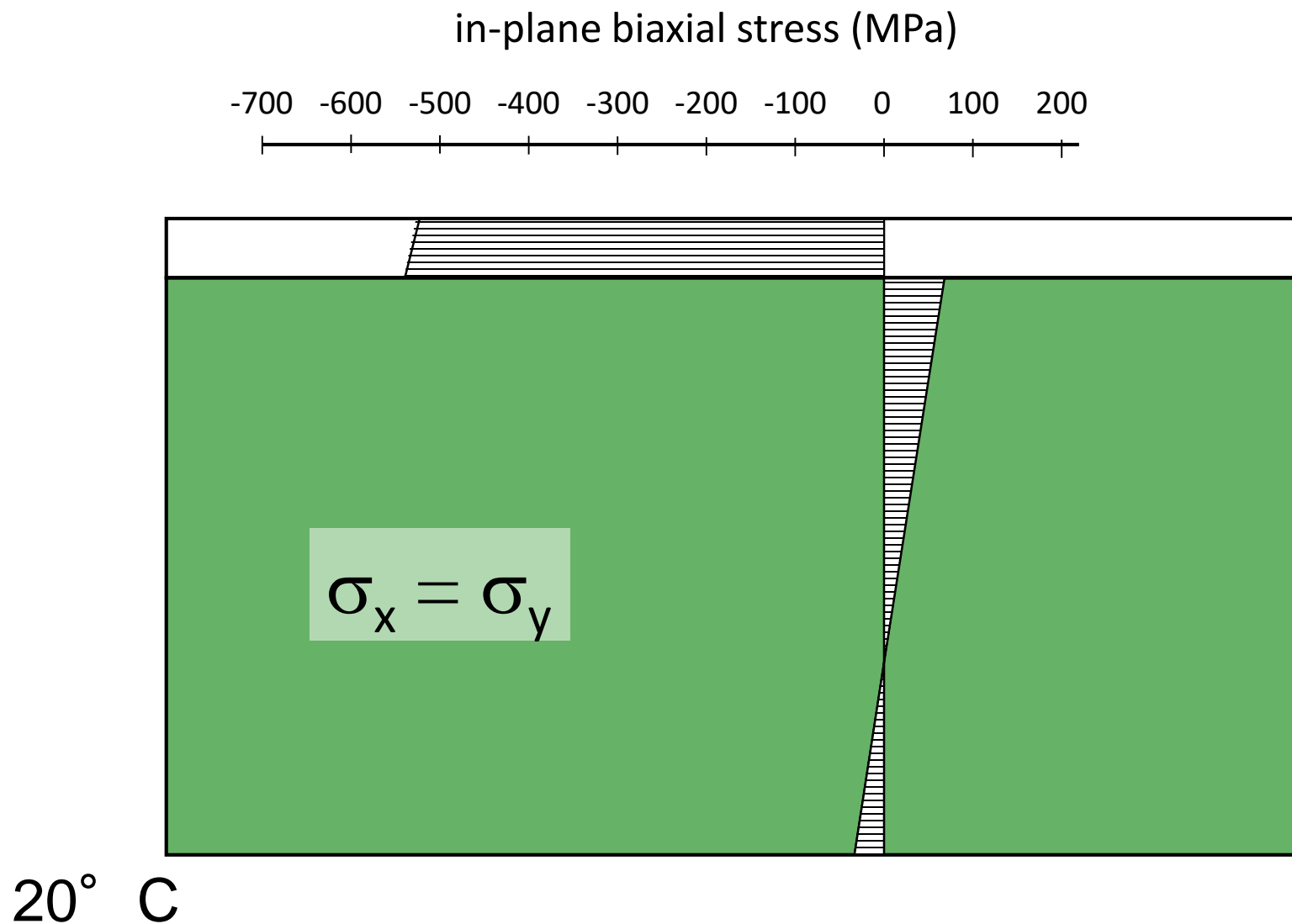
Residual Stresses in YSZ-NiO-YSZ bilayer



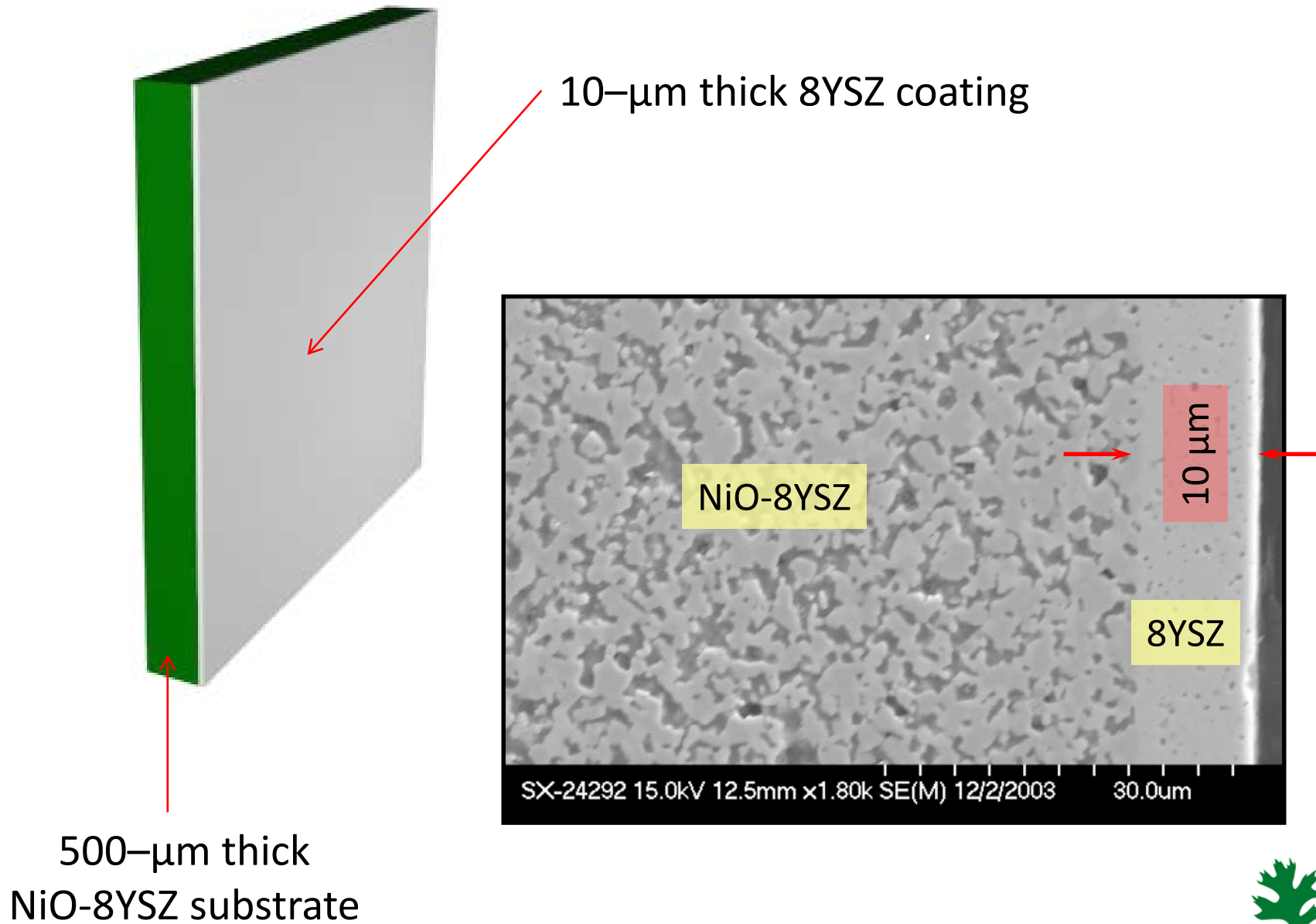
Residual Stresses in YSZ-NiO-YSZ bilayer



Residual Stresses in YSZ-NiO-YSZ bilayer



NiO-YSZ/YSZ bilayer

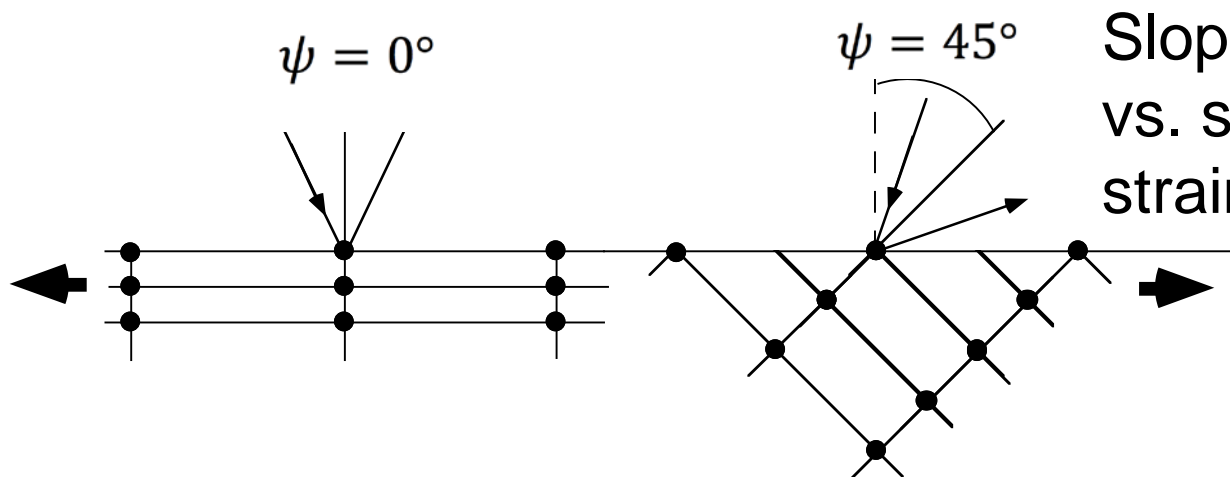


Measurement of Residual Stresses

- PANalytical X'pert PRO diffractometer
- CuK α radiation ($\lambda=1.540598 \text{ \AA}$)
- YSZ phase (6 2 0) Reflection
- $2\theta=141^\circ-144.5^\circ$ - using the $\sin^2\psi$ method. A maximum $\psi=55^\circ$ was used with equal steps of $\sin^2\psi$ with 7 steps (positive and negative tilts)

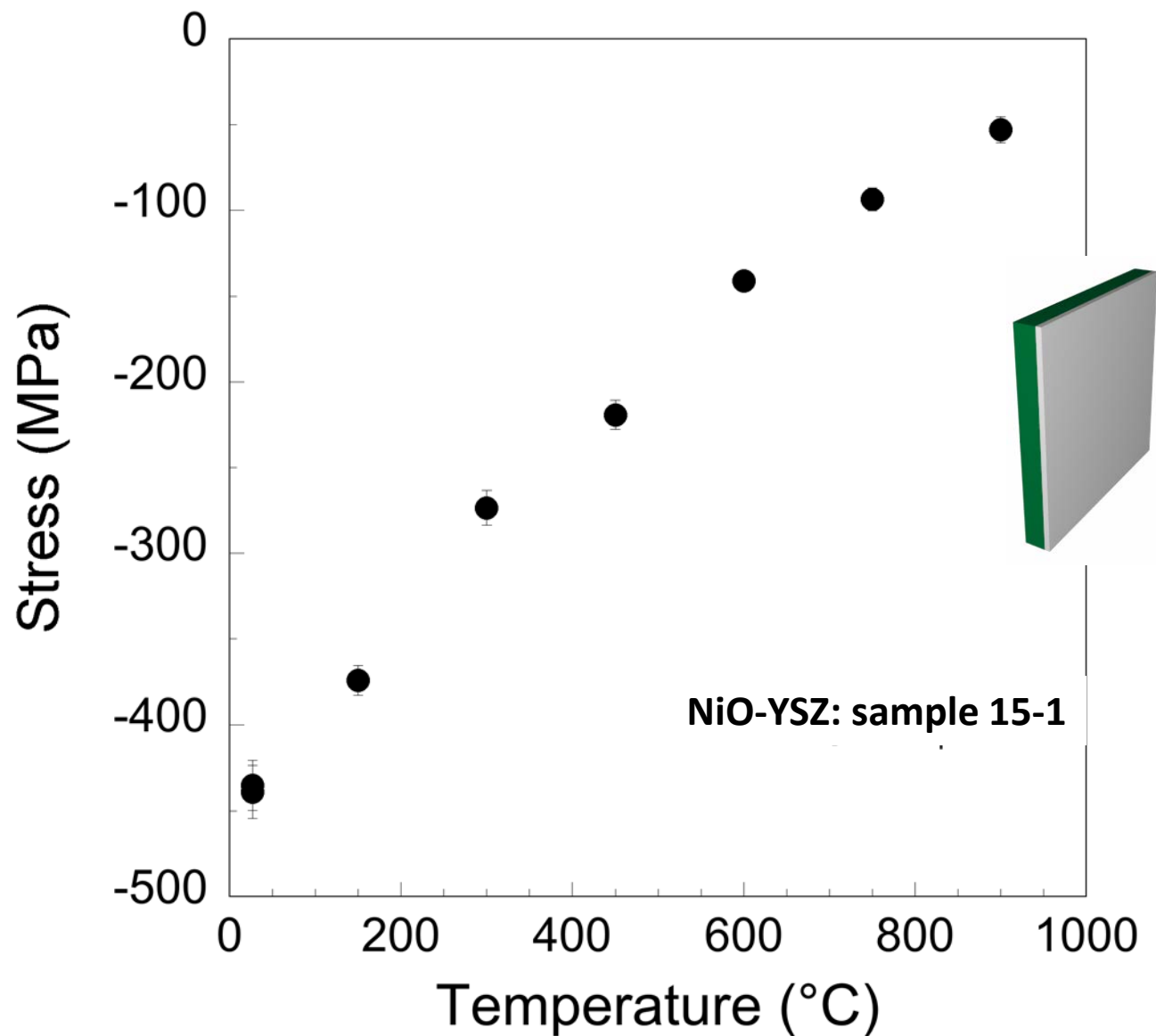


High-temperature
Diffractometer

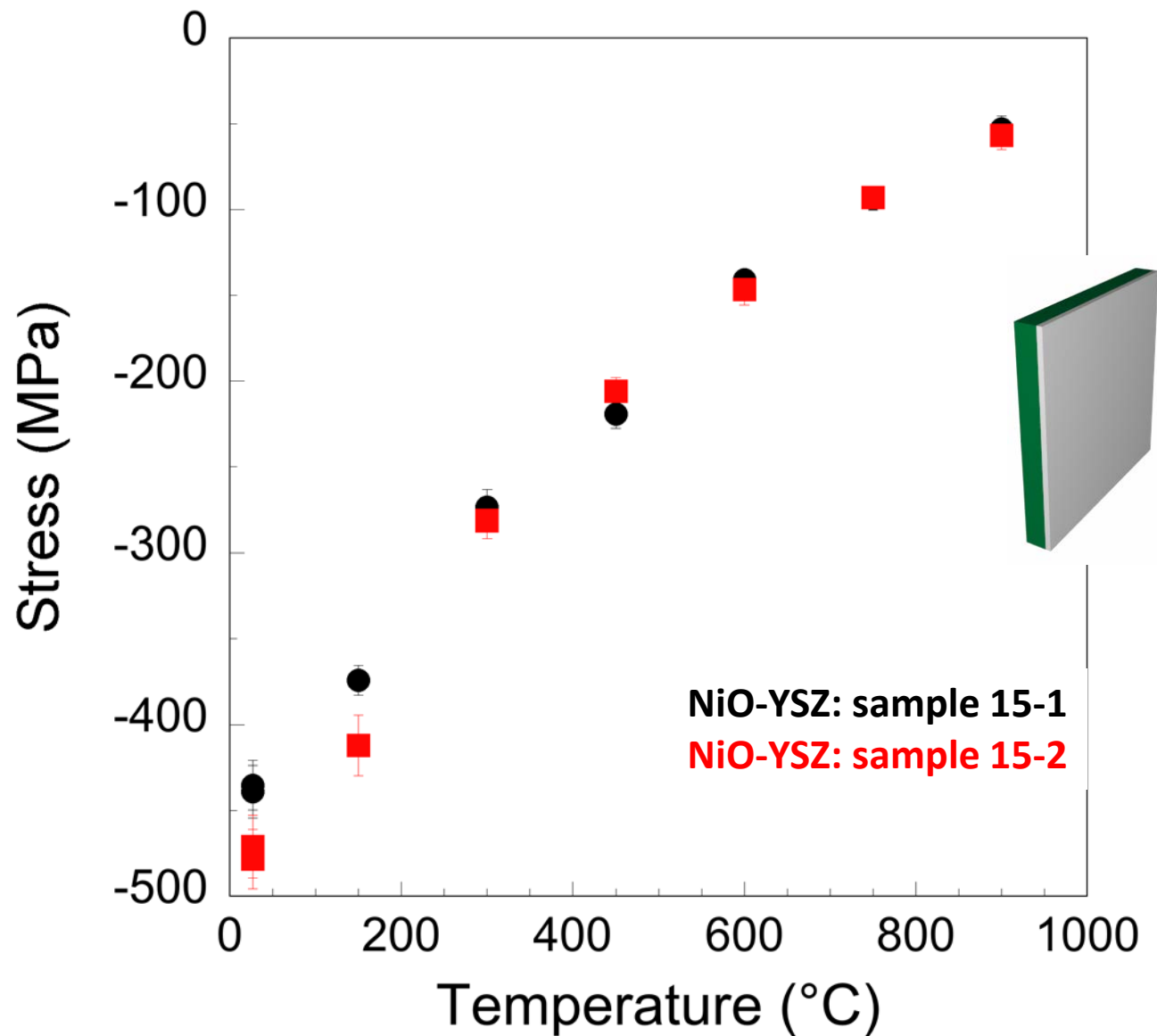


Slope of d (interplanar spacing) vs. $\sin^2\psi$ is used to calculate strain.

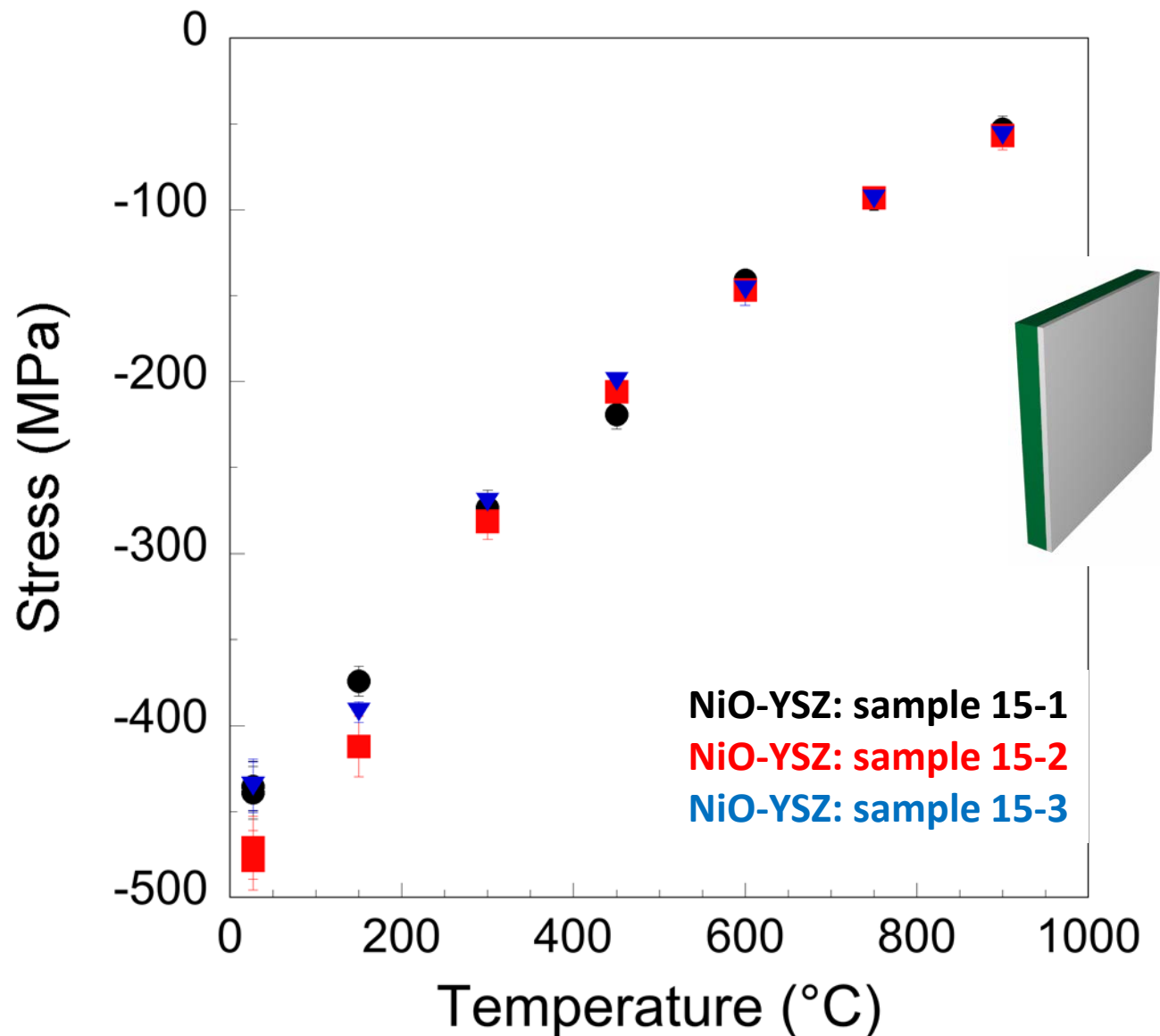
Residual Stresses in YSZ-NiO-YSZ bilayer



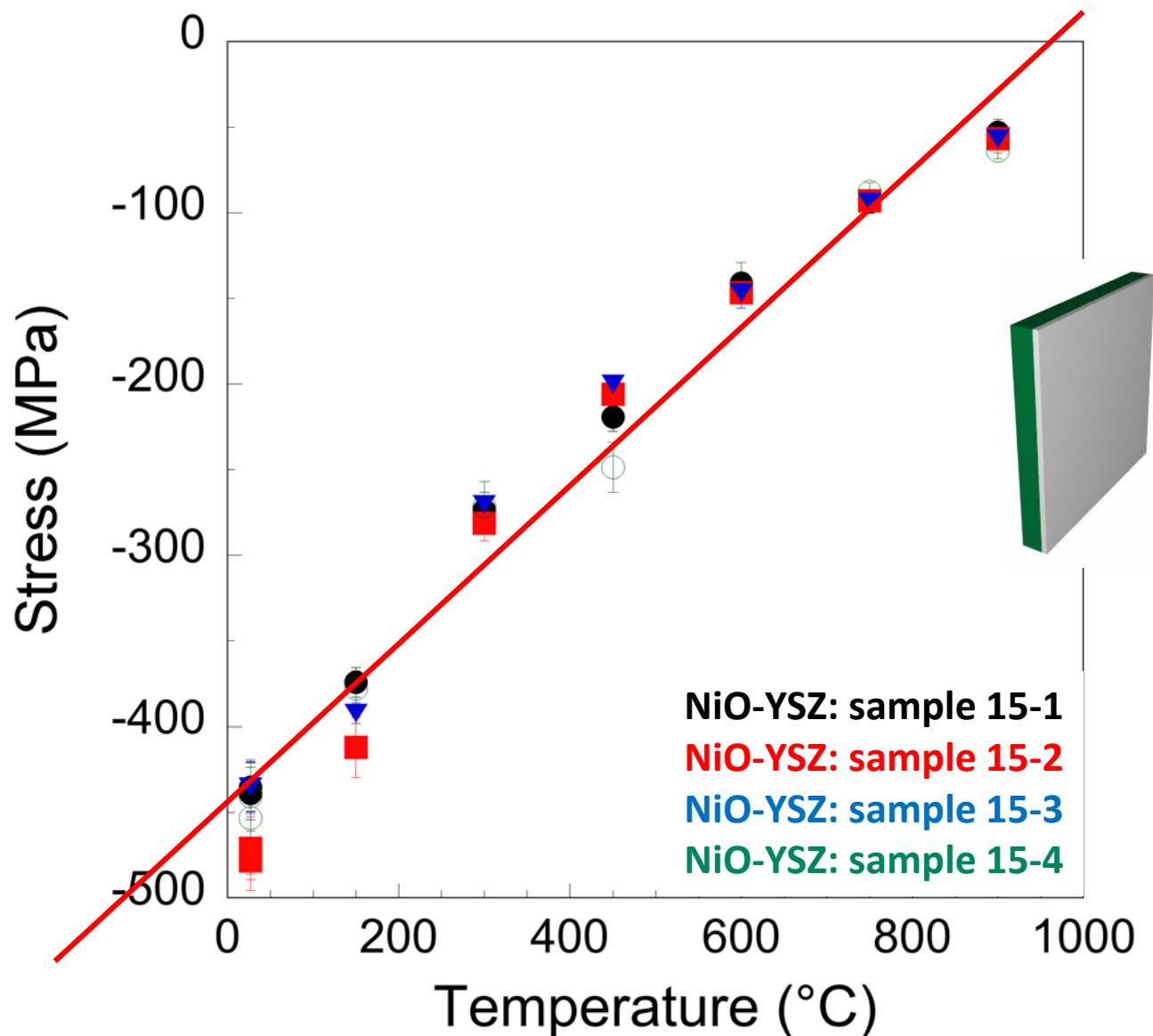
Residual Stresses in YSZ-NiO-YSZ bilayer



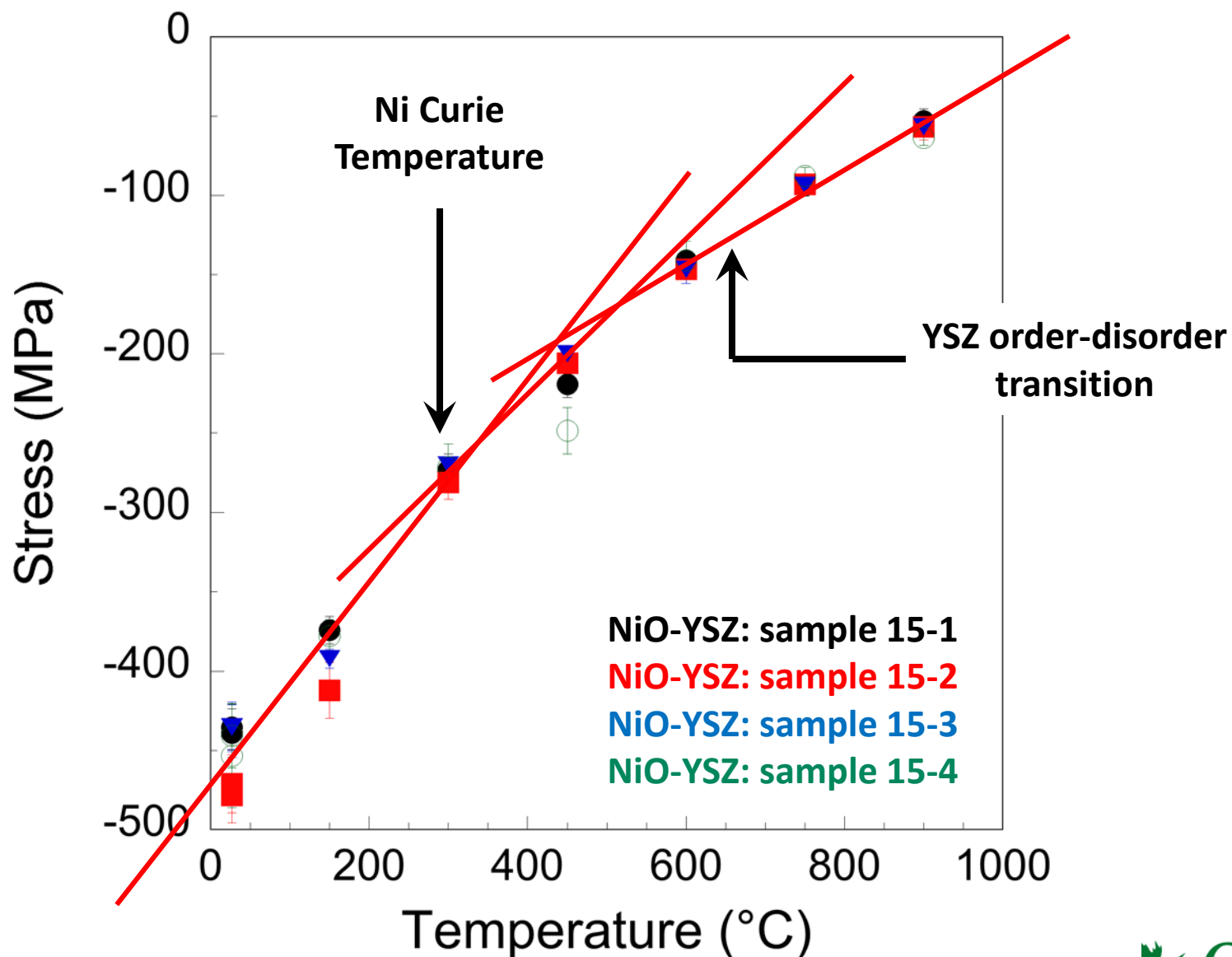
Residual Stresses in YSZ-NiO-YSZ bilayer



Residual Stresses in YSZ-NiO-YSZ bilayer



Residual Stresses in YSZ-NiO-YSZ bilayer

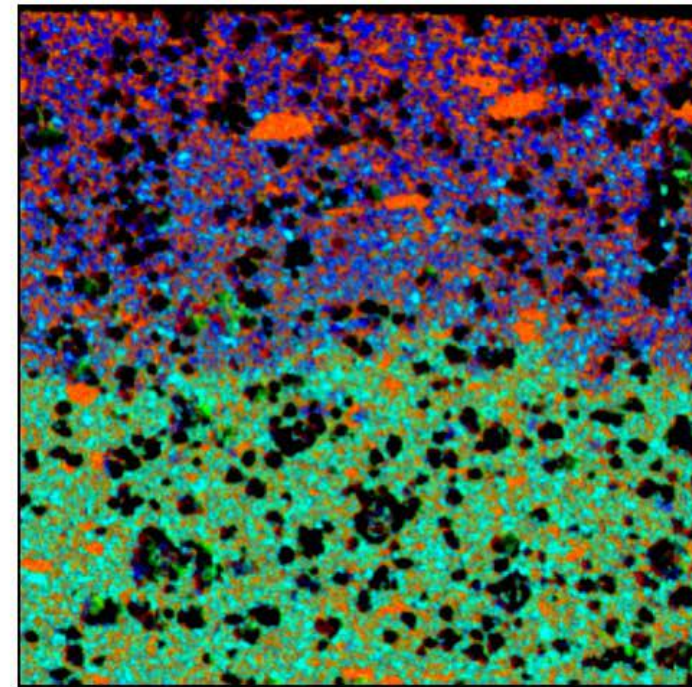
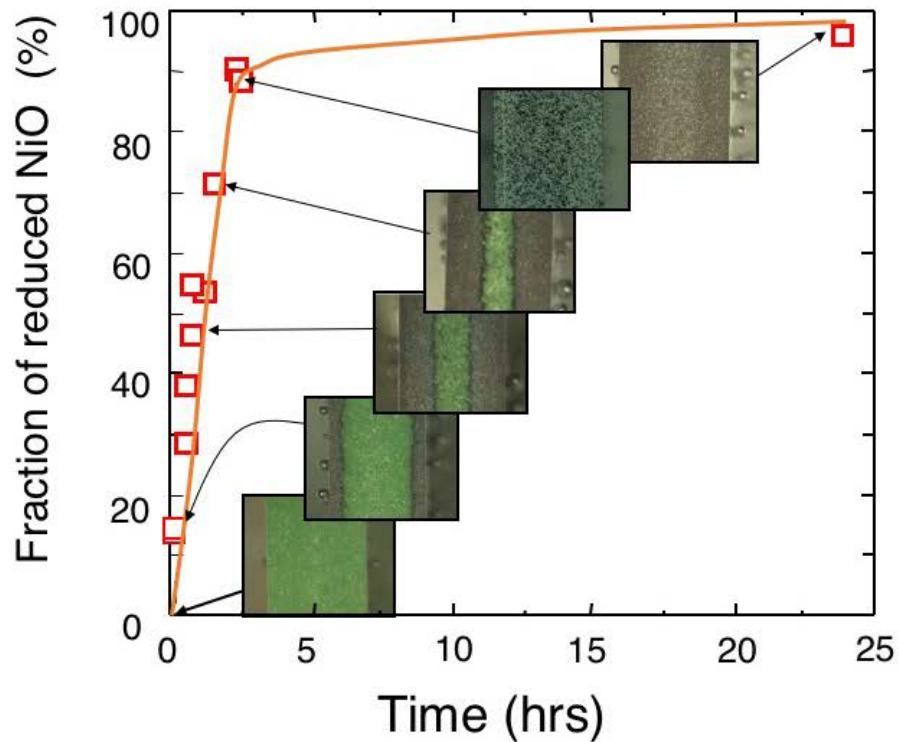


NiO Reduction

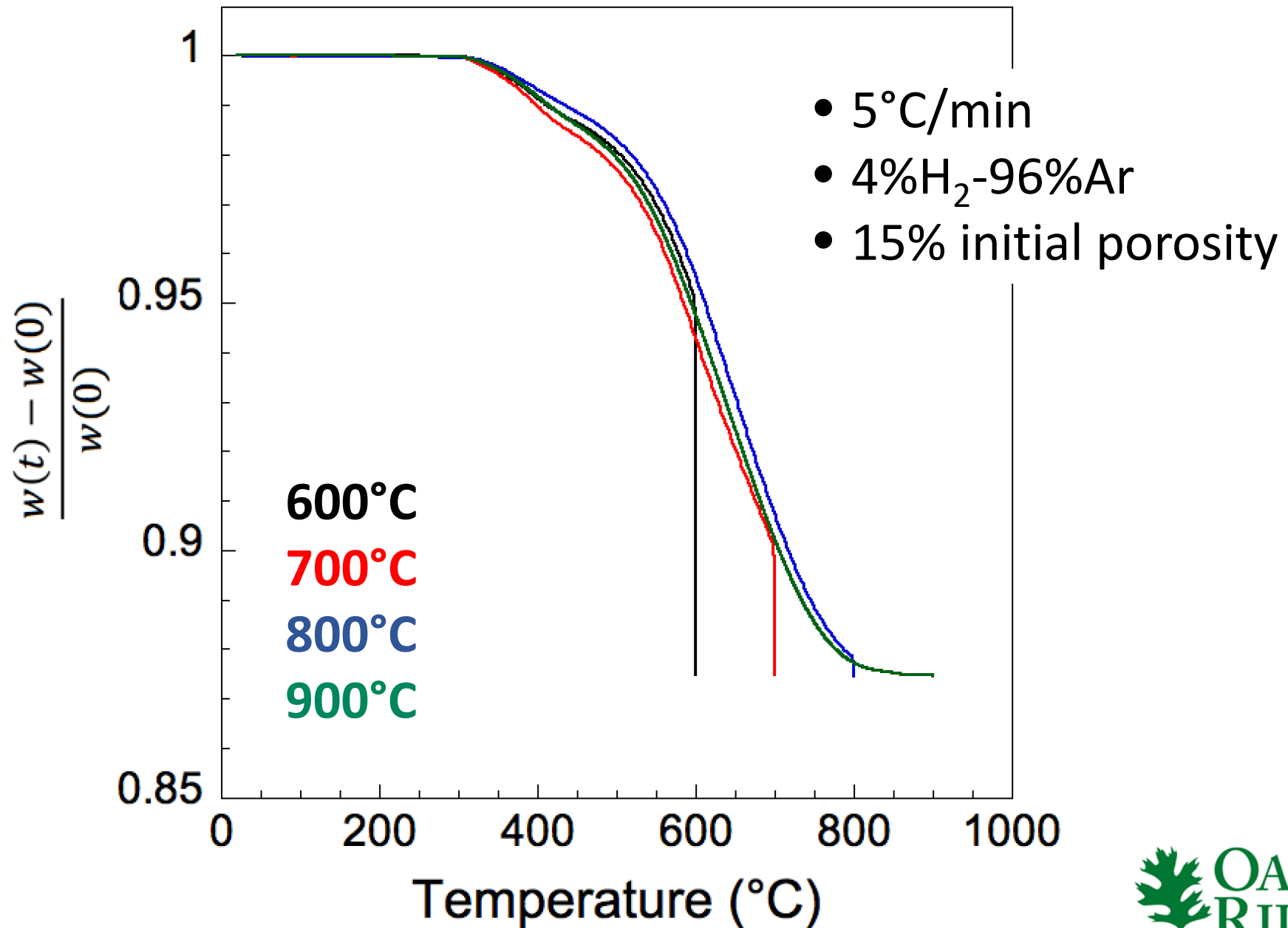
Elastic Properties of Nickel-Based Anodes for Solid Oxide Fuel Cells as a Function of the Fraction of Reduced NiO

Miladin Radovic* and Edgar Lara-Curzio*

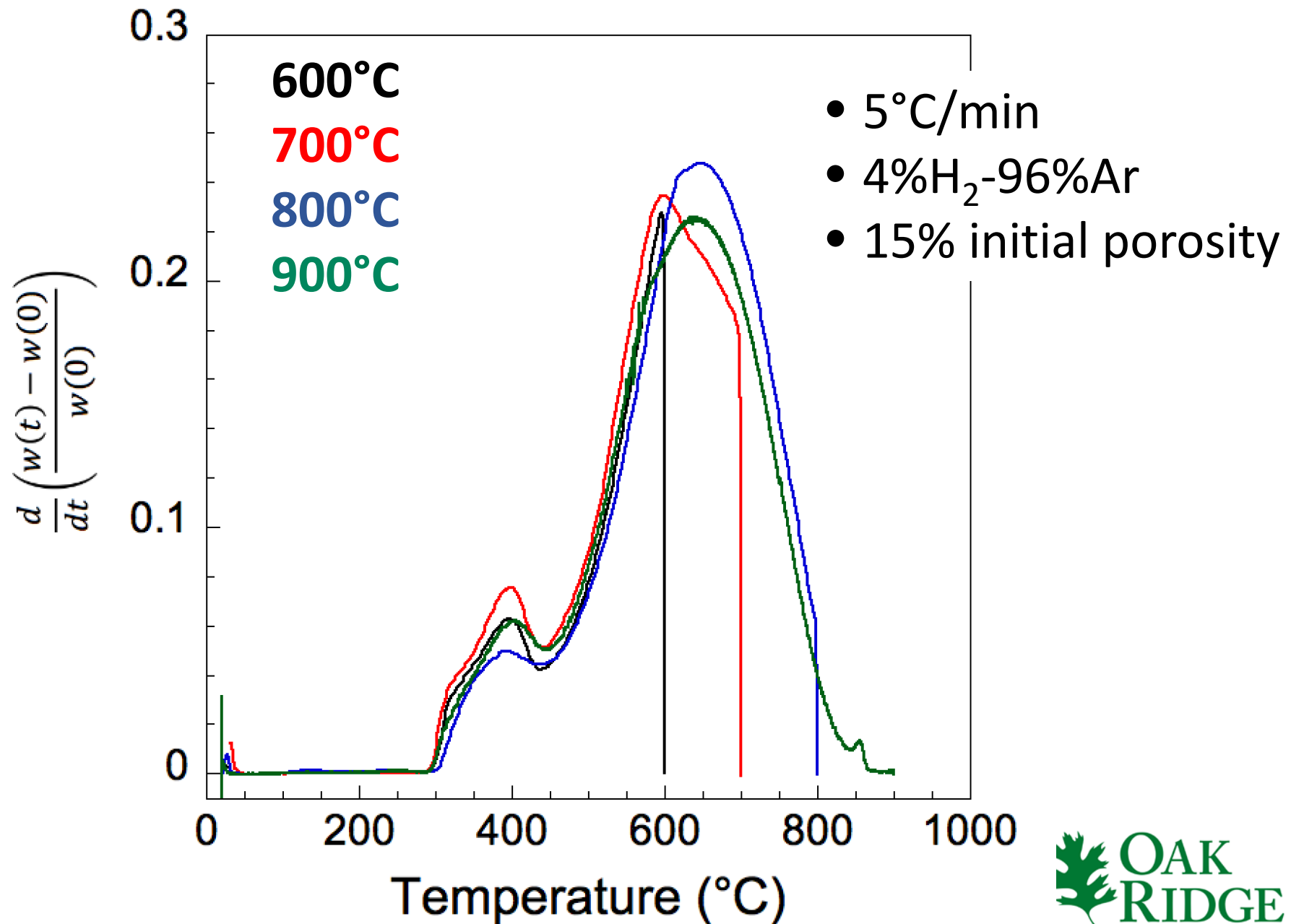
Metals and Ceramics Division, Oak Ridge National Laboratory, Oak Ridge, Tennessee 37831-6069



Reduction of NiO-YSZ



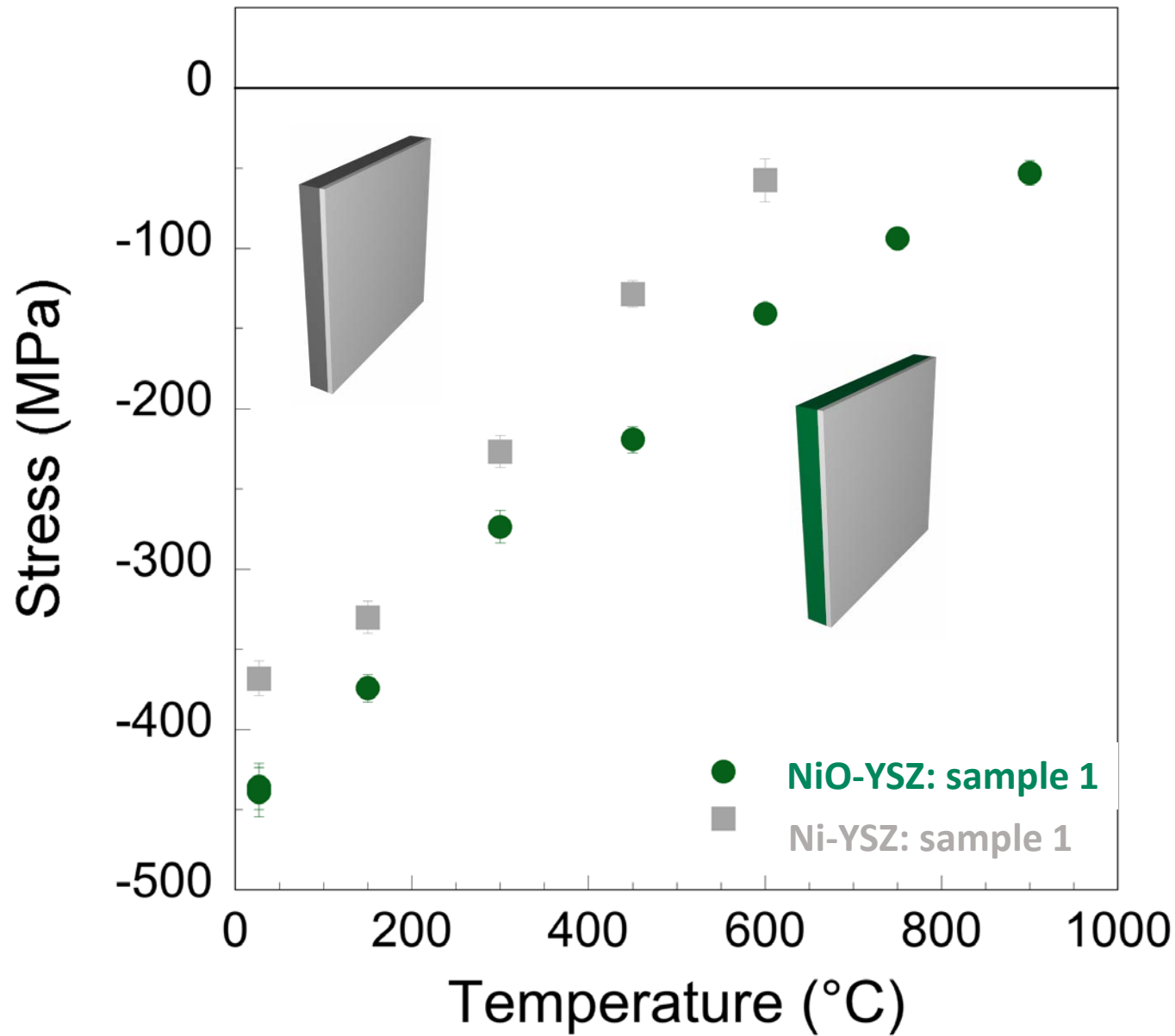
Reduction of NiO-YSZ



Effect of NiO Reduction Temperature on Residual Stresses

Reduction of NiO-YSZ

Reduction Temperature: 600°C

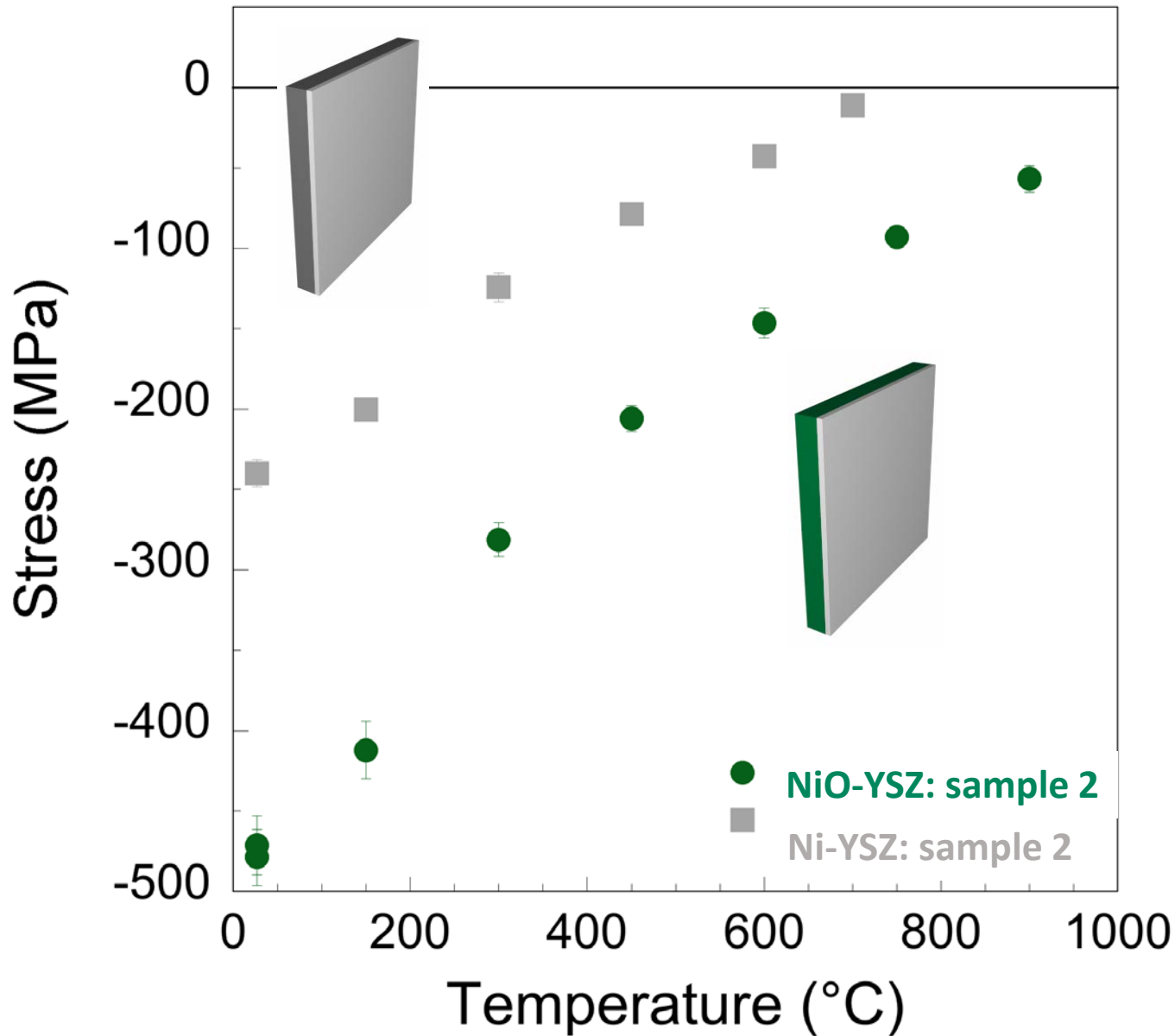


Porosity

- NiO-YSZ: 15%
- Ni-YSZ: 34%

Reduction of NiO-YSZ

Reduction Temperature: 700°C

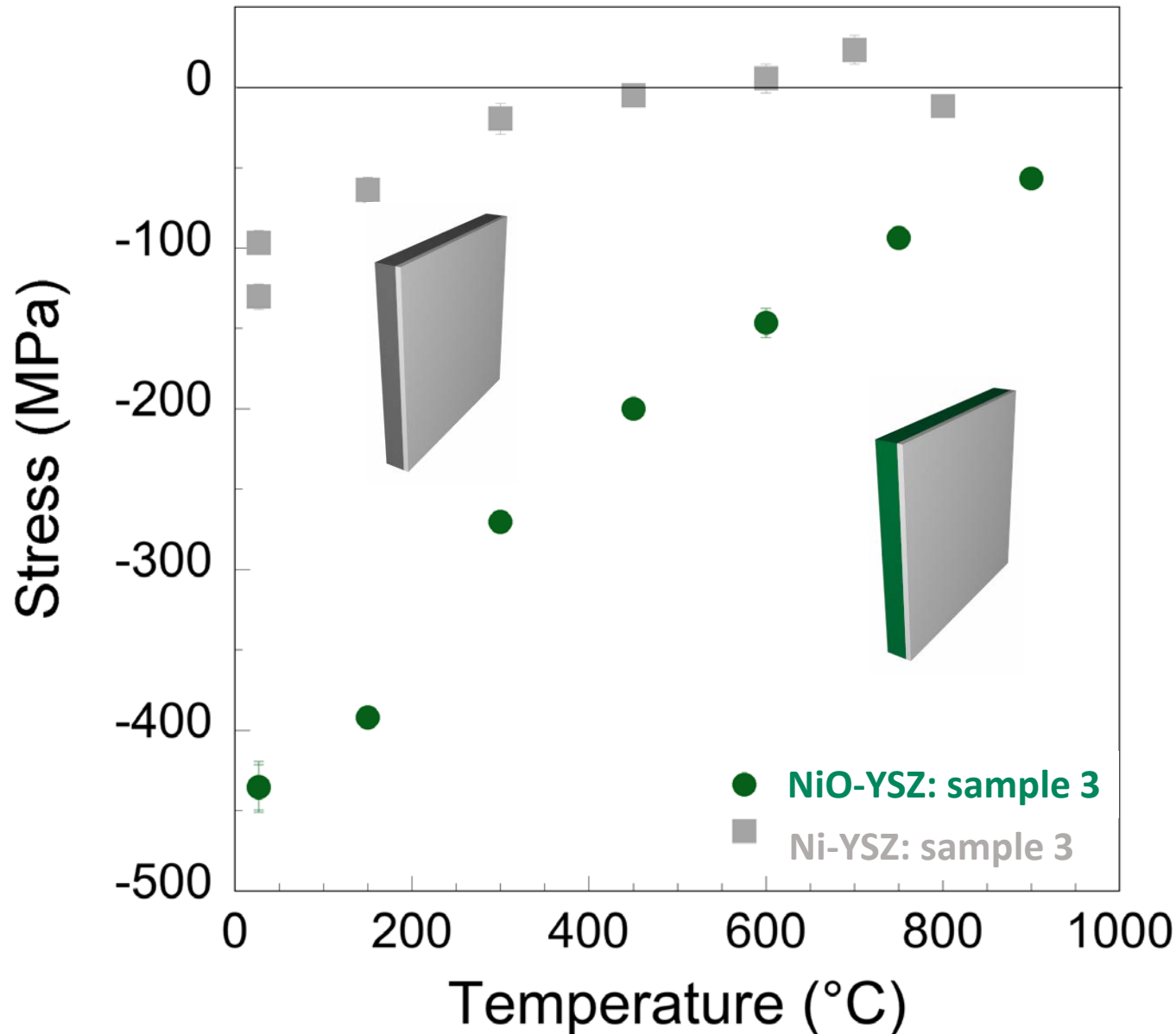


Porosity

- NiO-YSZ: 15%
- Ni-YSZ: 34%

Reduction of NiO-YSZ

Reduction Temperature: 800°C

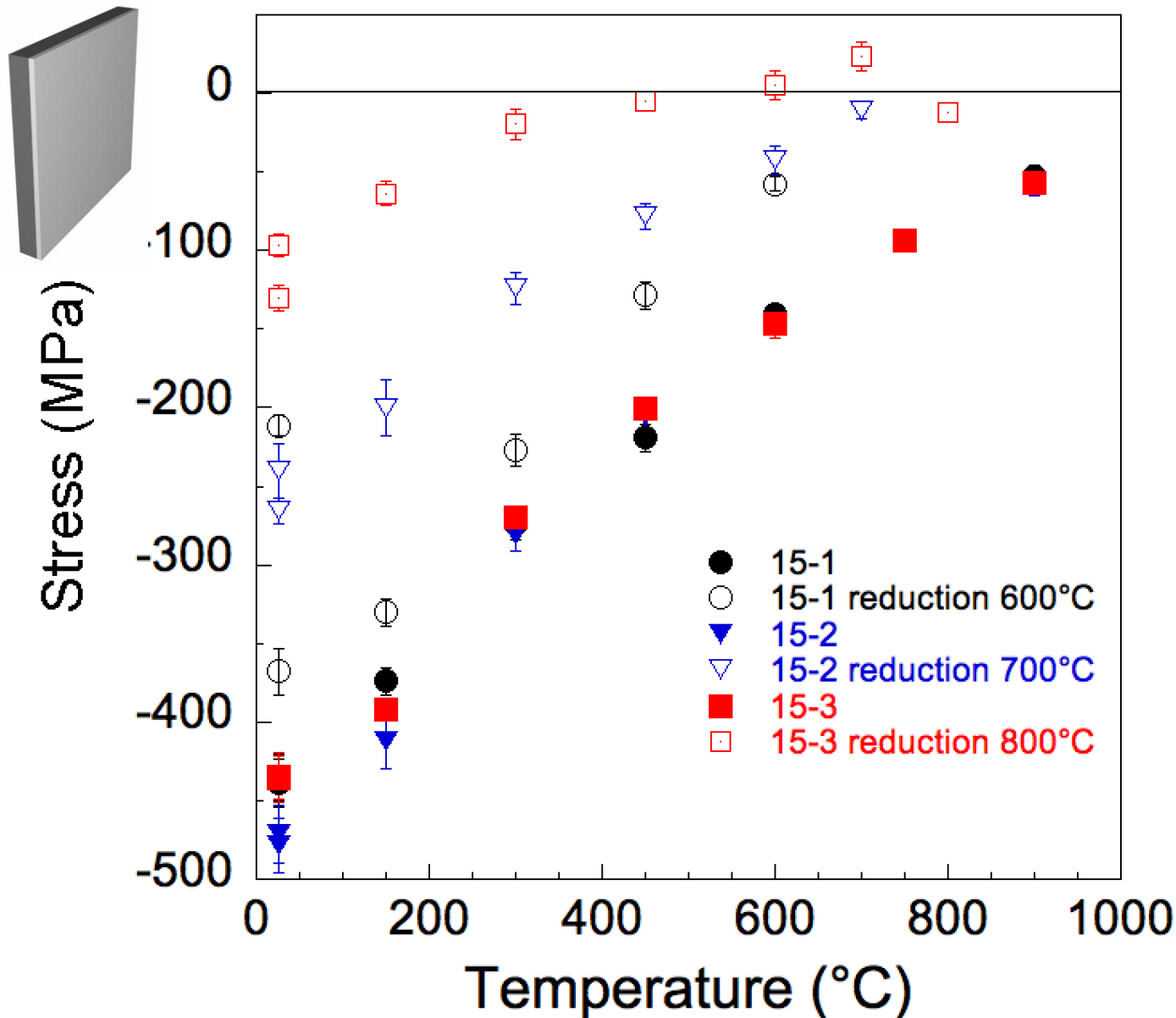


Porosity

- NiO-YSZ: 15%
- Ni-YSZ: 34%

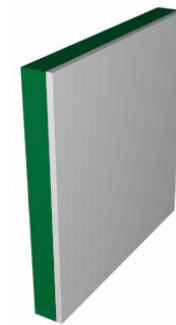
Reduction of NiO-YSZ

Effect of Reduction Temperature



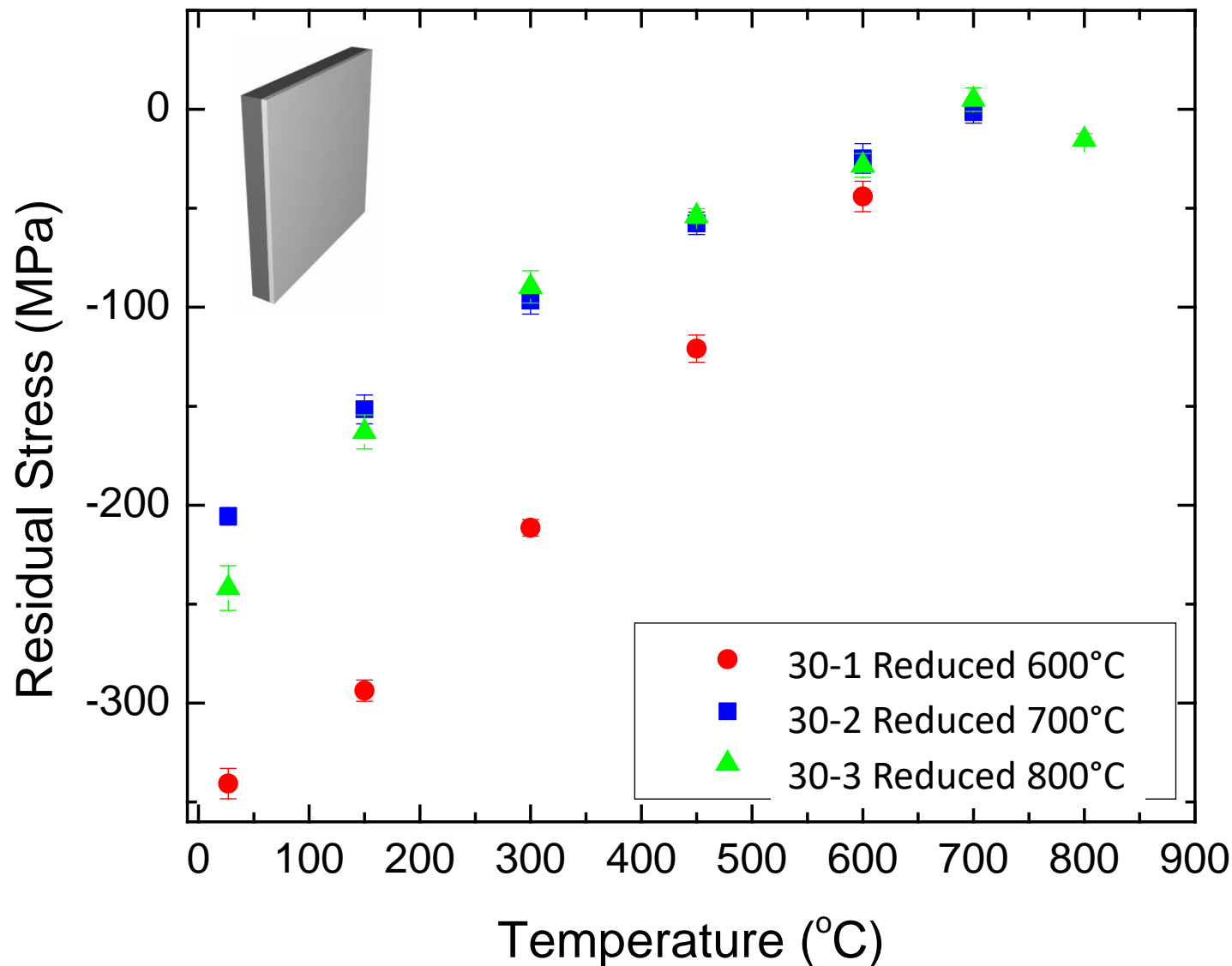
Porosity

- NiO-YSZ: 15%
- Ni-YSZ: 34%



Reduction of NiO-YSZ

Effect of Reduction Temperature



Porosity

- NiO-YSZ: 30%
- Ni-YSZ: 45%

Creep Behavior of Ni-YSZ

Questions

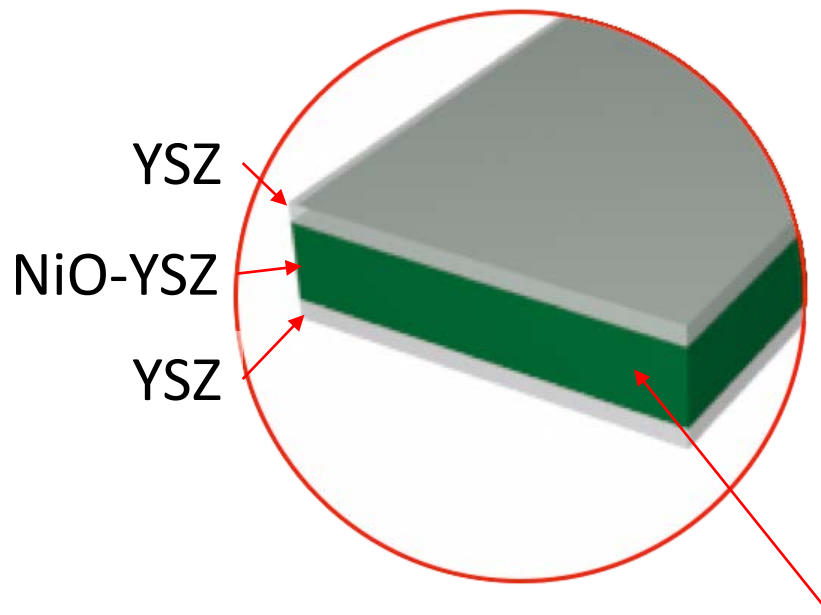
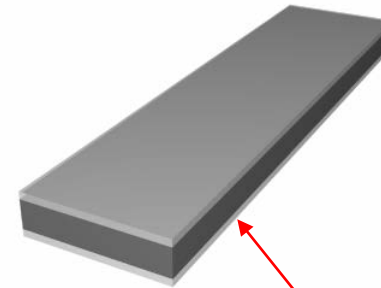
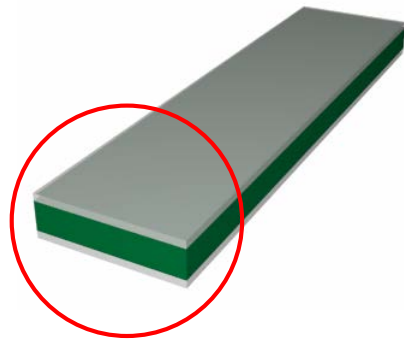
- Do **operational** stresses induce creep deformation?
- Does creep deformation change the microstructure of anode materials?
- If yes, how do these changes affect the functionality of the anode?
- If the layers bonded to the anode (e.g., electrolyte and interconnect) creep less than the anode, how do stresses experienced by the anode get redistributed to the neighboring layers?

Materials for Creep testing (Sandwich Configuration)

As-processed

After reduction

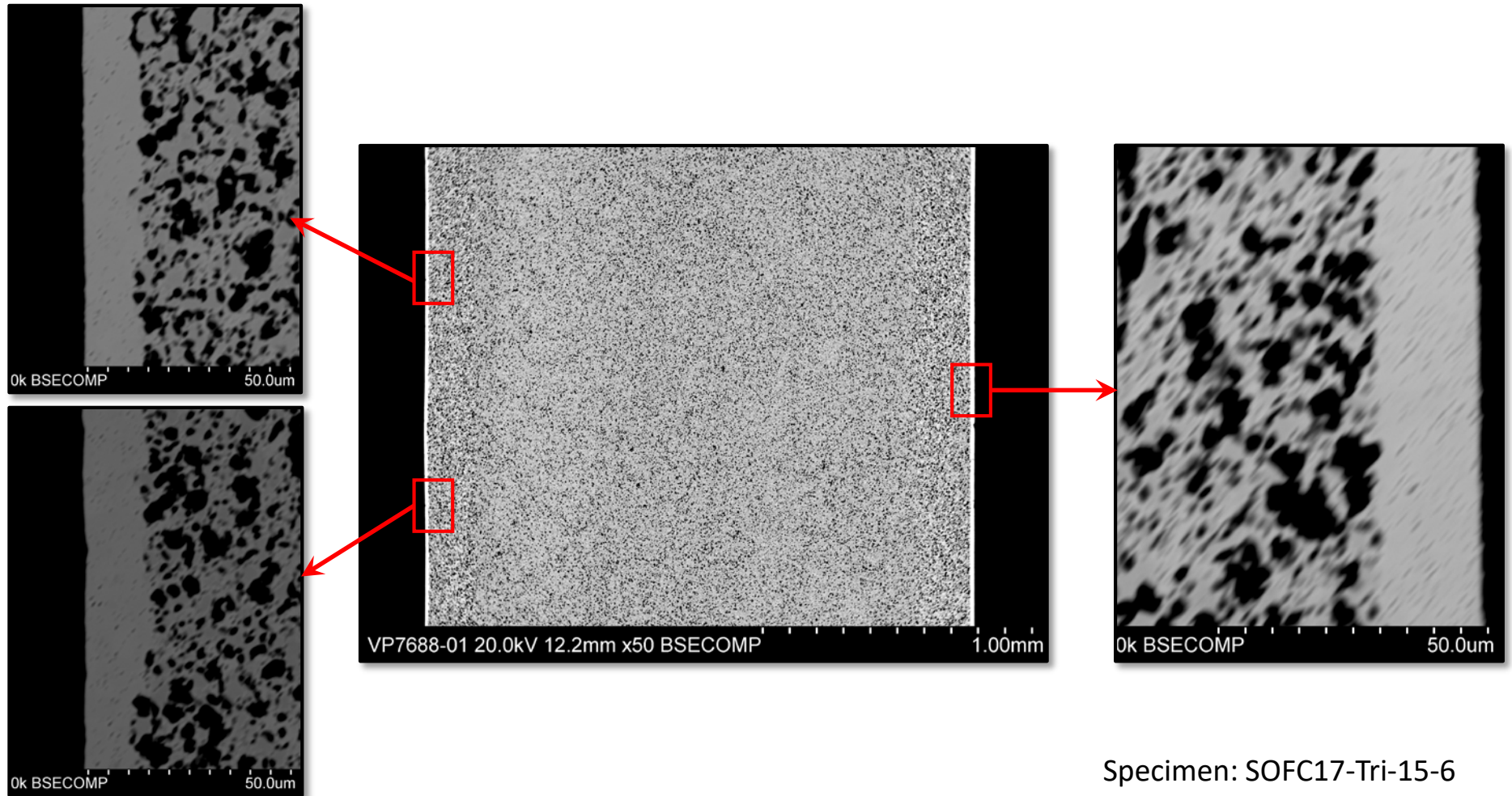
YSZ thickness
~2 μm
~20 μm
~40 μm



Porosity
34%
45%
53%

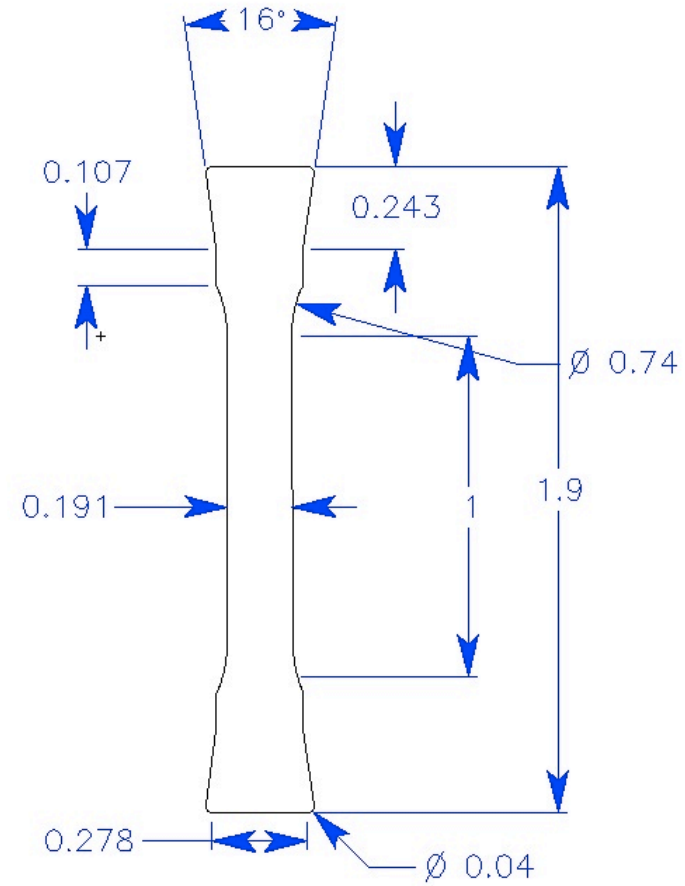
Porosity
15%
30%
40%

YSZ/Ni-YSZ/YSZ Sandwich Specimen

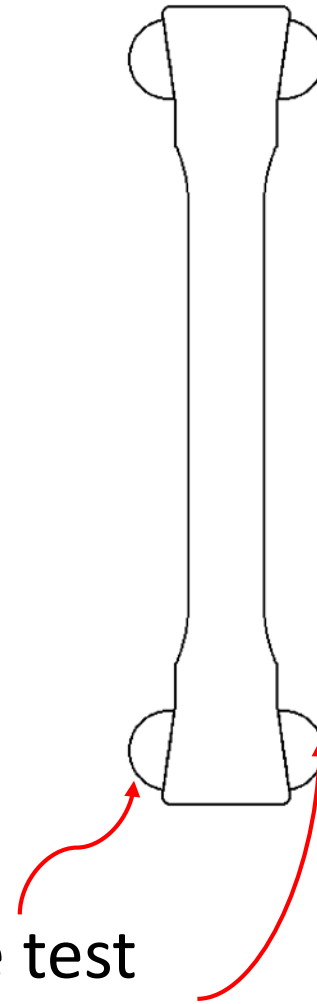


Specimen: SOFC17-Tri-15-6

Shoulder-loaded Tensile Specimen

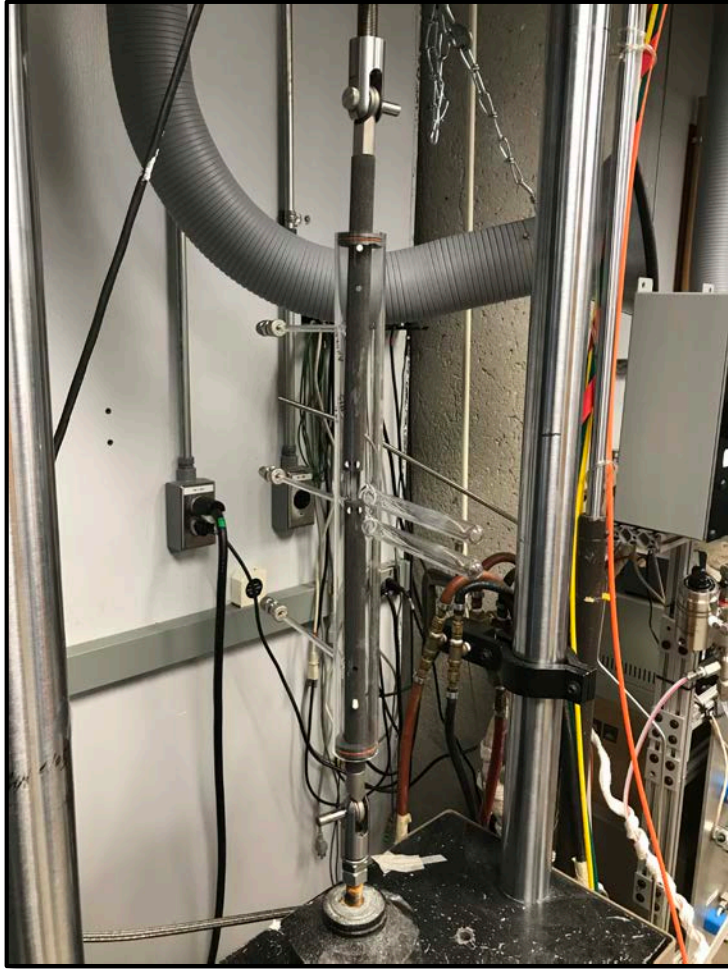


Creep Testing Facility



Load is transferred to the test specimen through its shoulders

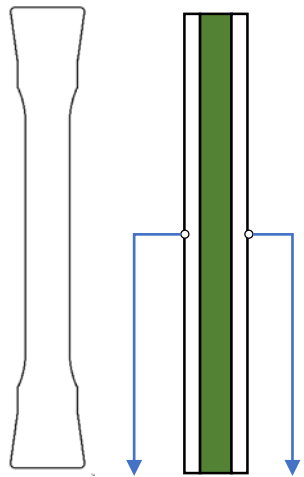
Creep Testing Facility



- High temperature
- Controlled environment

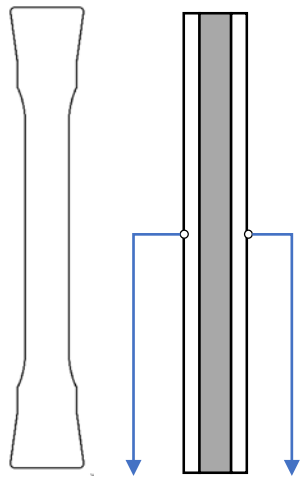
Methodology (Residual Stress Measurements)

As-processed



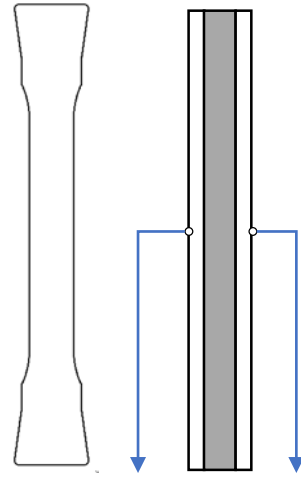
Residual Stress Measurement

After Reduction

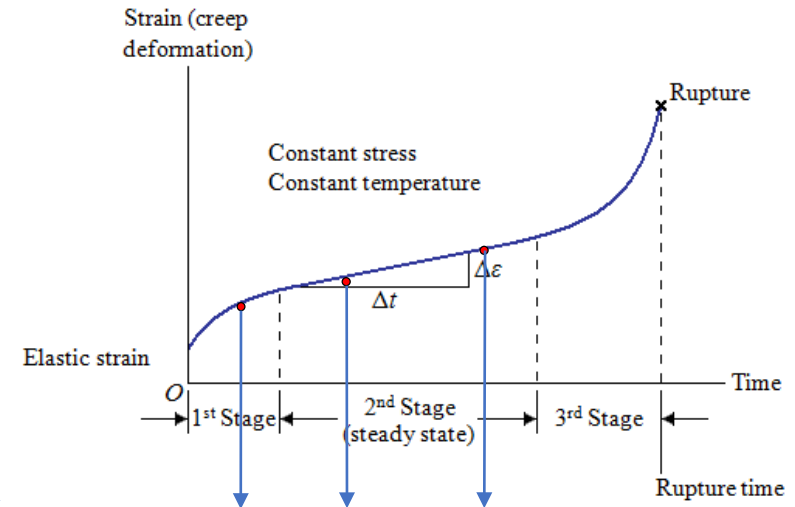


Residual Stress Measurement

After Creep Deformation
(by interrupting creep tests)

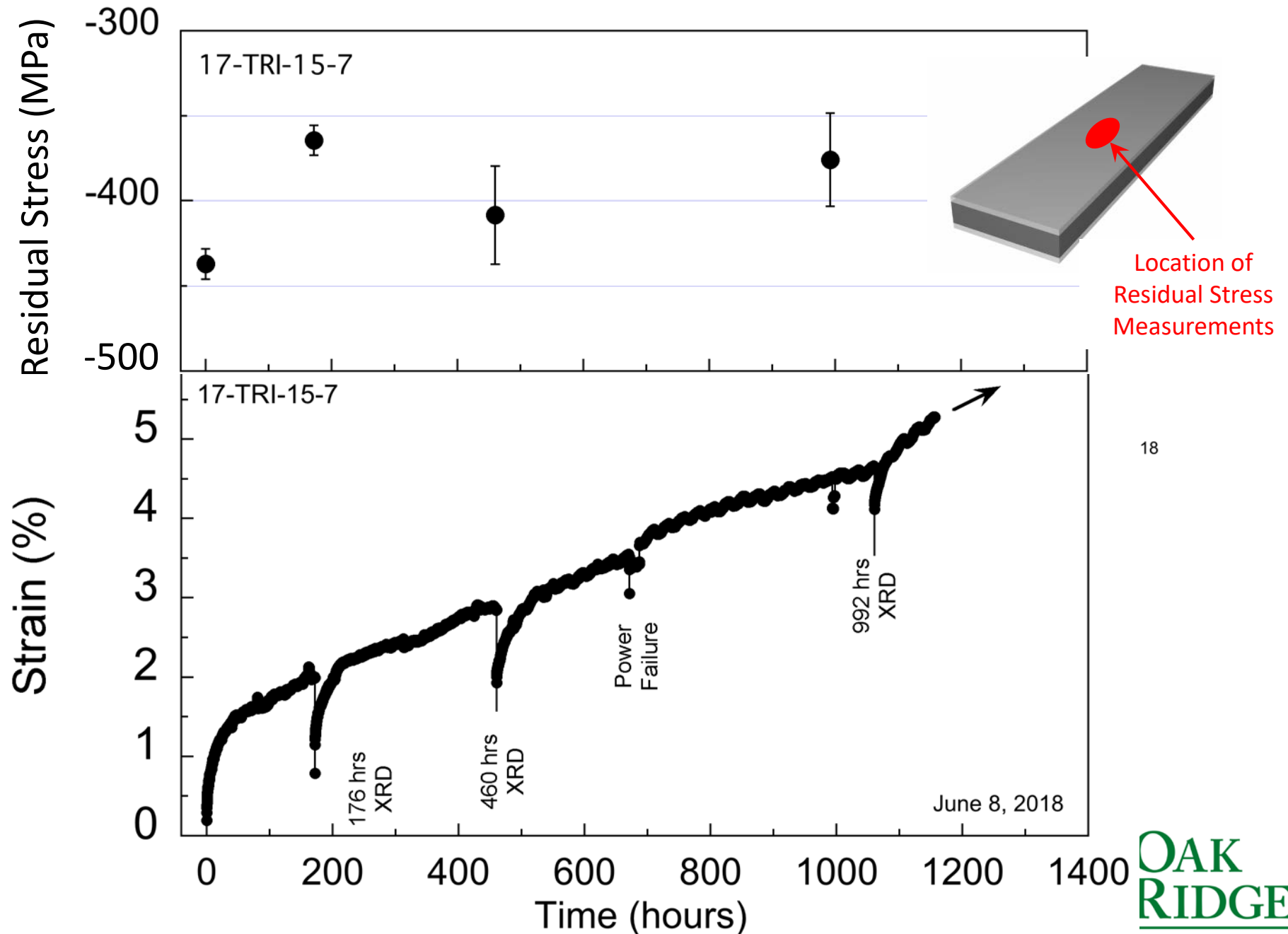


Residual Stress Measurement



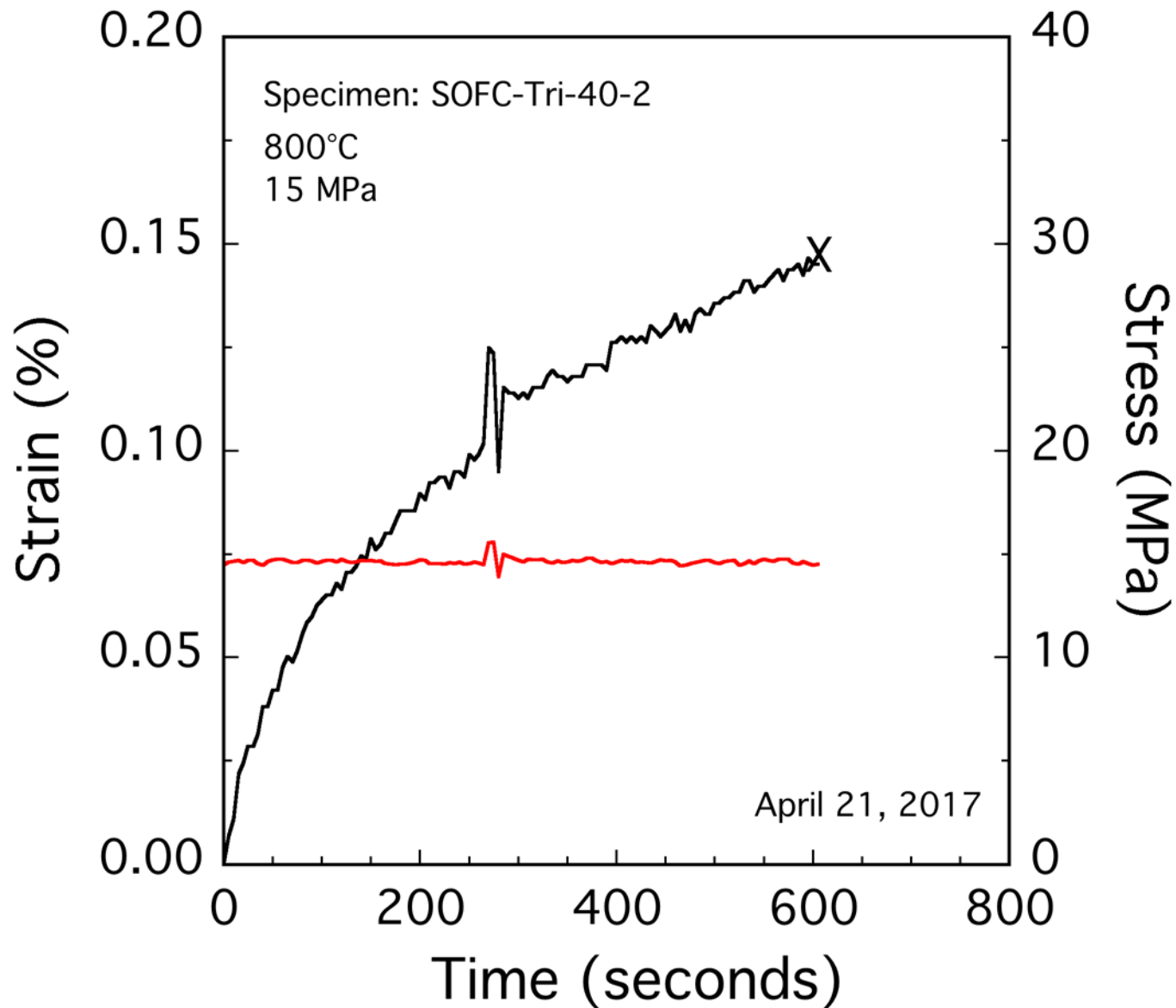
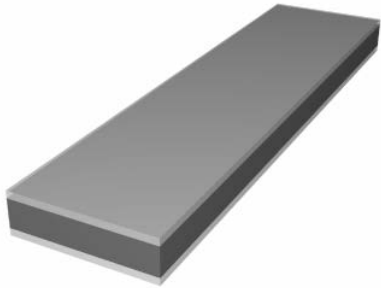
Interrupted creep test

Creep-Induced Redistribution of Residual Stresses

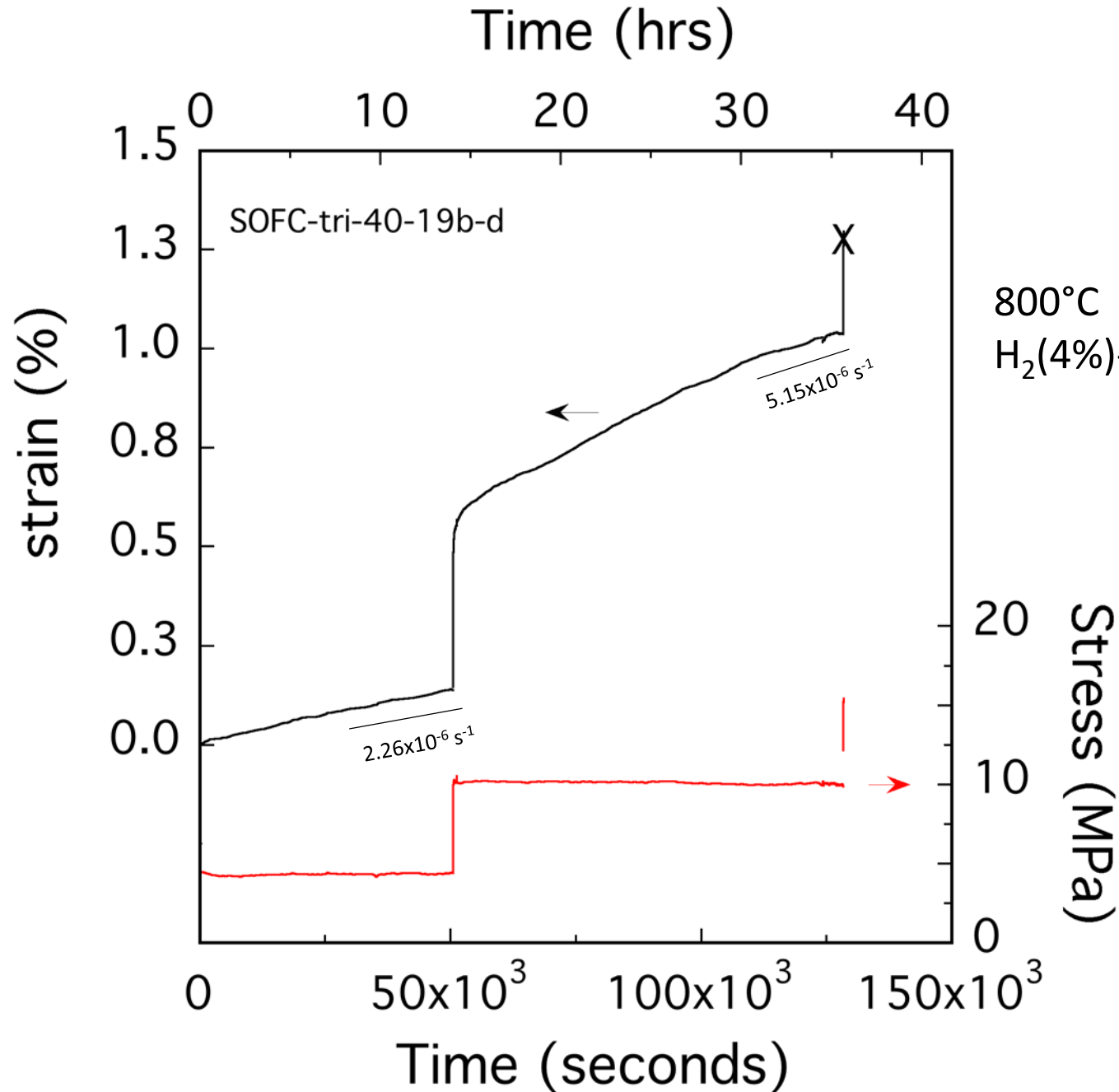


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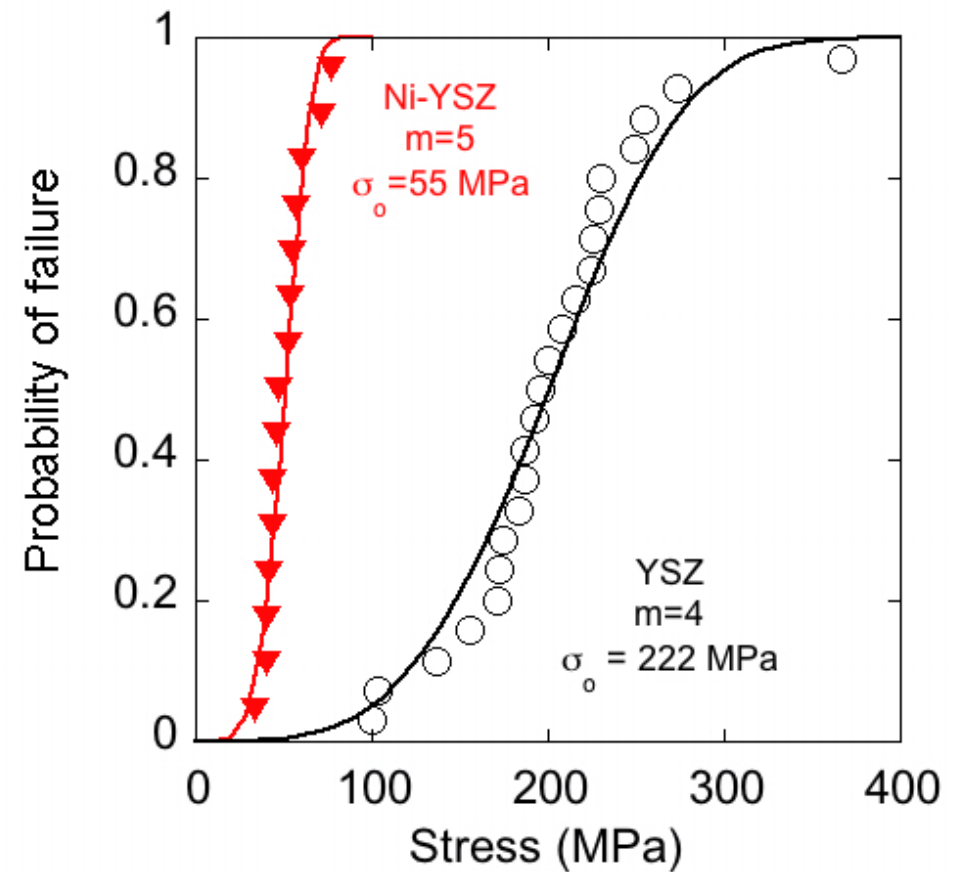
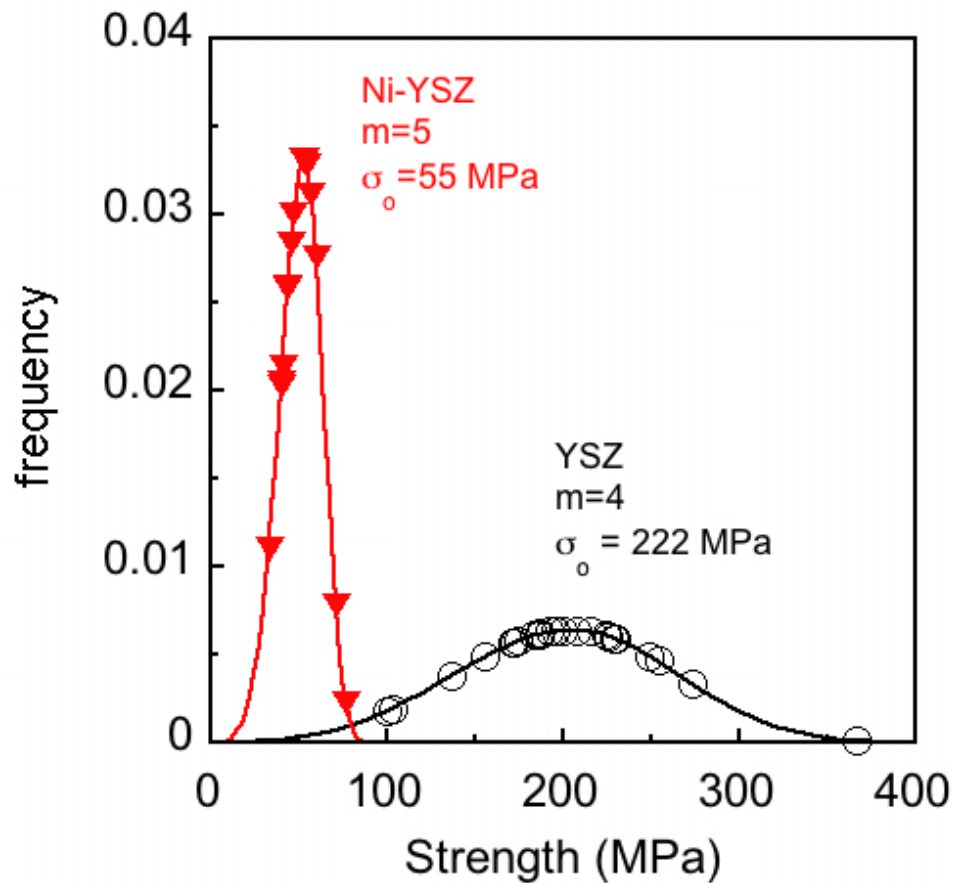
Creep Testing Results



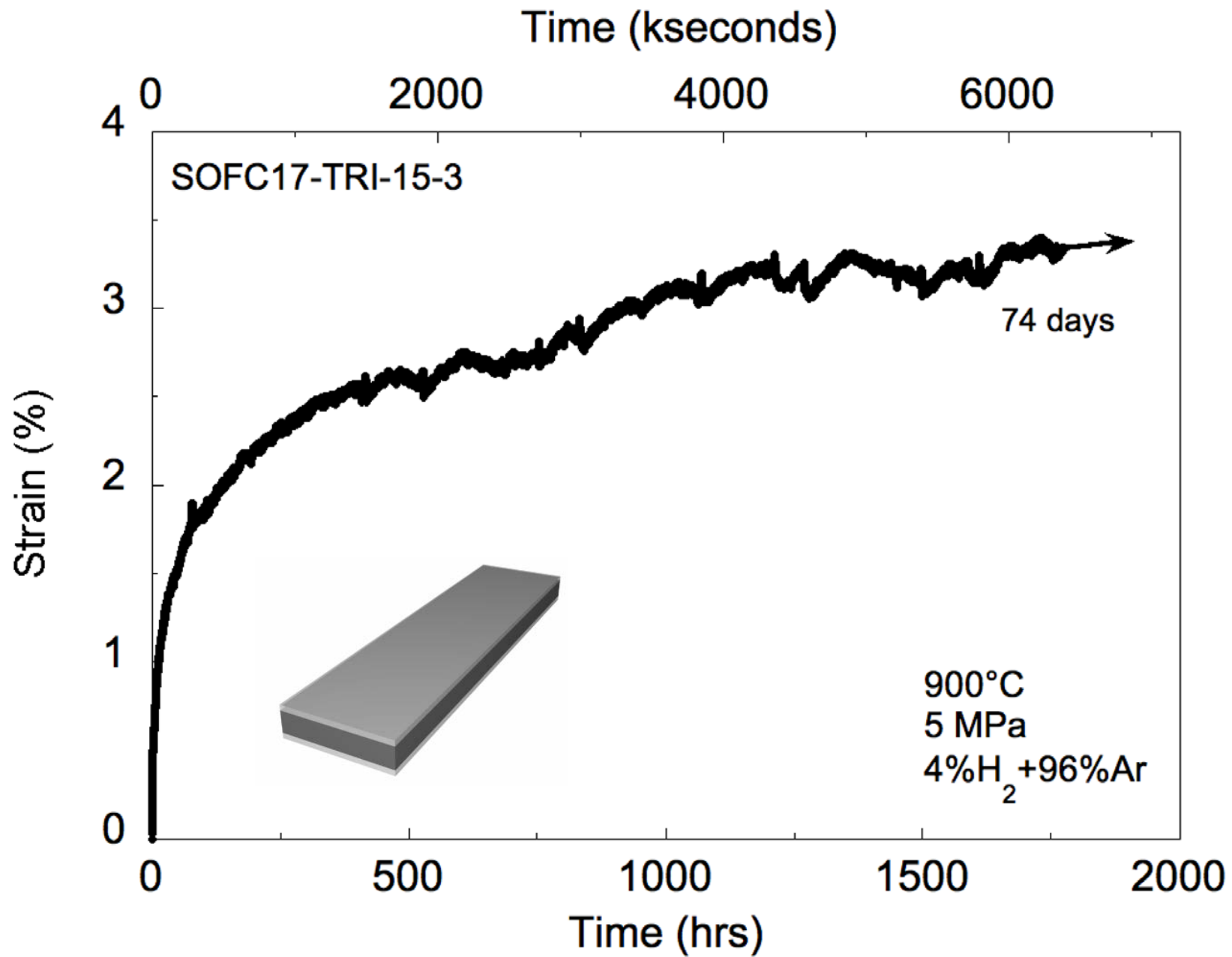
Creep Testing Results



Strength of SOFC materials



Creep Behavior of YSZ/Ni-YSZ/YSZ



Summary

- The state of residual stresses of YSZ/Ni-YSZ bilayers depends on reduction temperature
- The magnitude of residual stress decreases with increasing reduction temperature and porosity

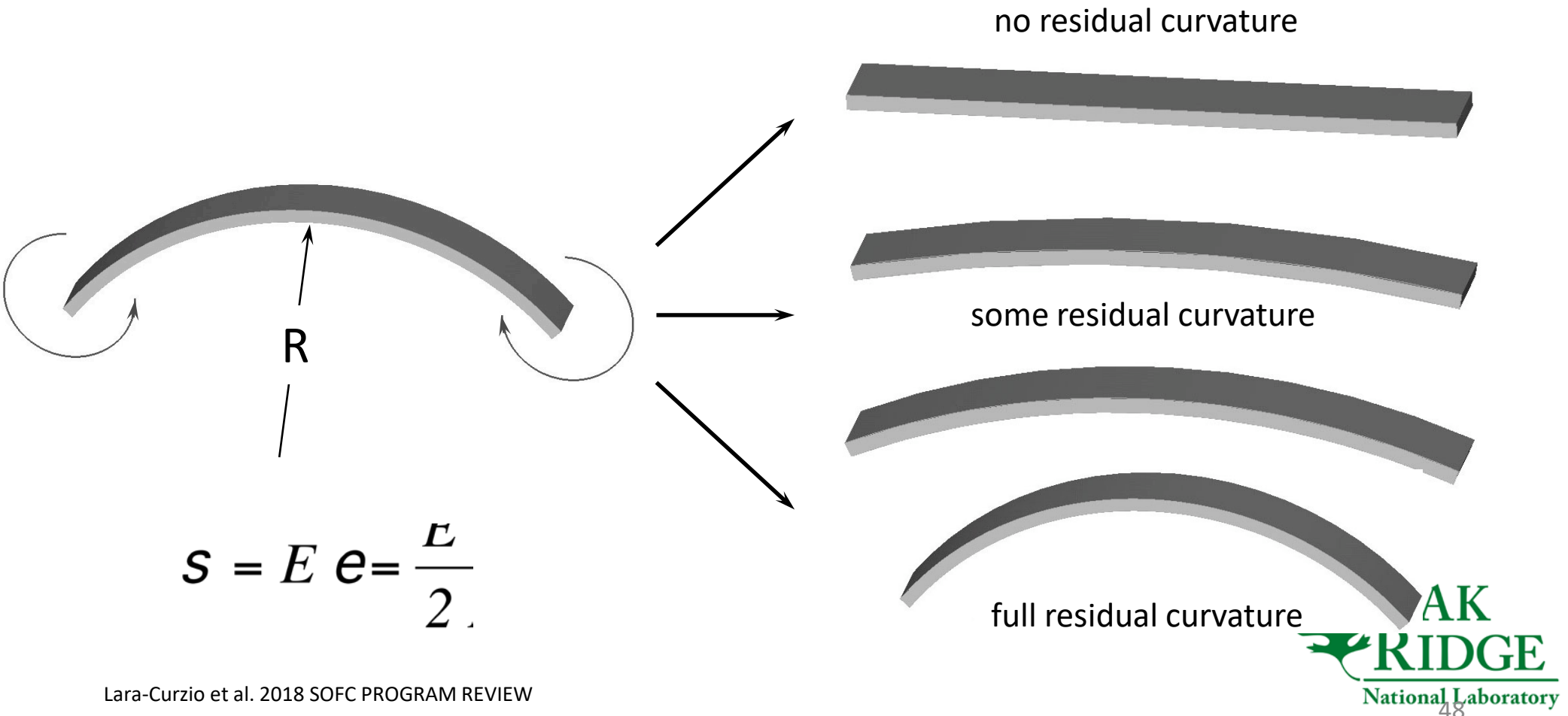
Summary

- Effect of creep deformation on the microstructure and functionality of anode materials is being investigated.
- The redistribution of stresses in SOFCs as a result of anode creep deformation is being measured using interrupted creep tests and x-ray diffraction.
- Preliminary results show that stresses get redistributed within a cell, which has implications on SOFC durability and reliability.

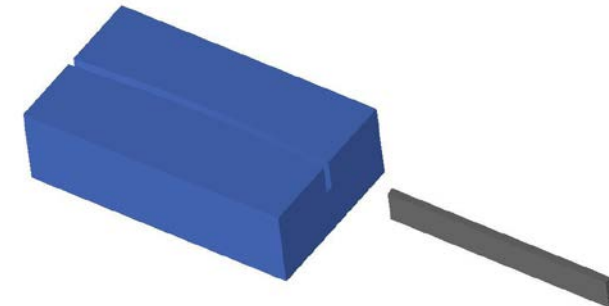
Time-dependent deformation

Let's subject a beam under a constant bending moment at a given temperature for a predetermined period of time.

At the end of the thermal treatment, let's remove the bending moment and measure the residual curvature of the beam by laser profilometry.



Time-dependent deformation Ni-YSZ (30% porosity)



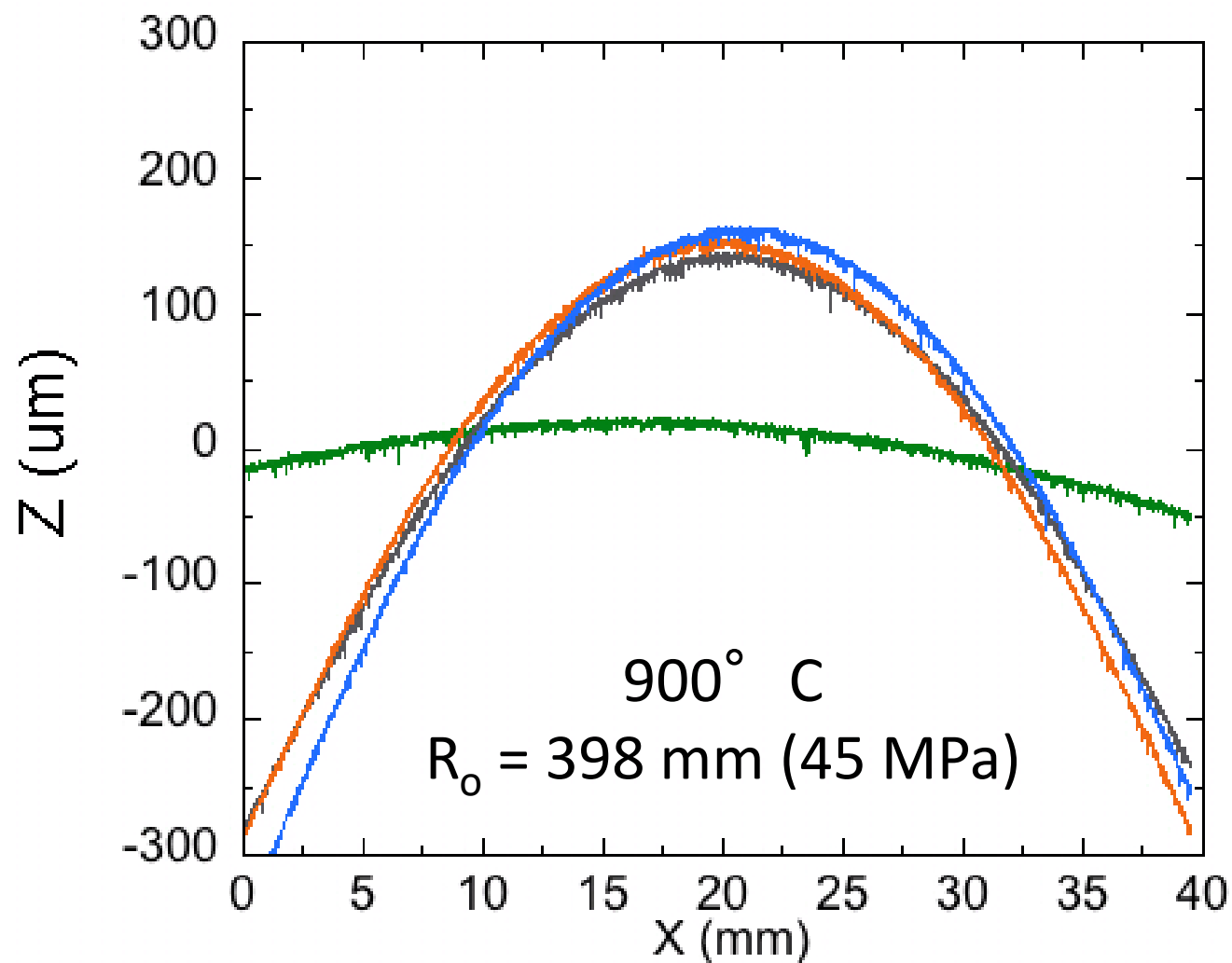
alumina fixtures

- 600° C
- 800° C
- 900° C
- 15, 30 and 45 MPa
- 4% H_2 +96%Ar

sample dimensions:

- 0.7 mm
- 4 mm
- 40 mm

Time-dependent deformation of Ni-YSZ



U	$\sigma / \%$
1	47
10	43
50	41



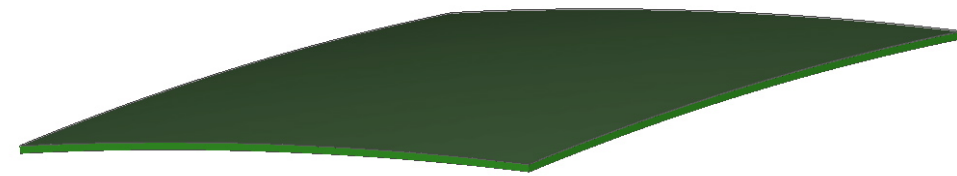
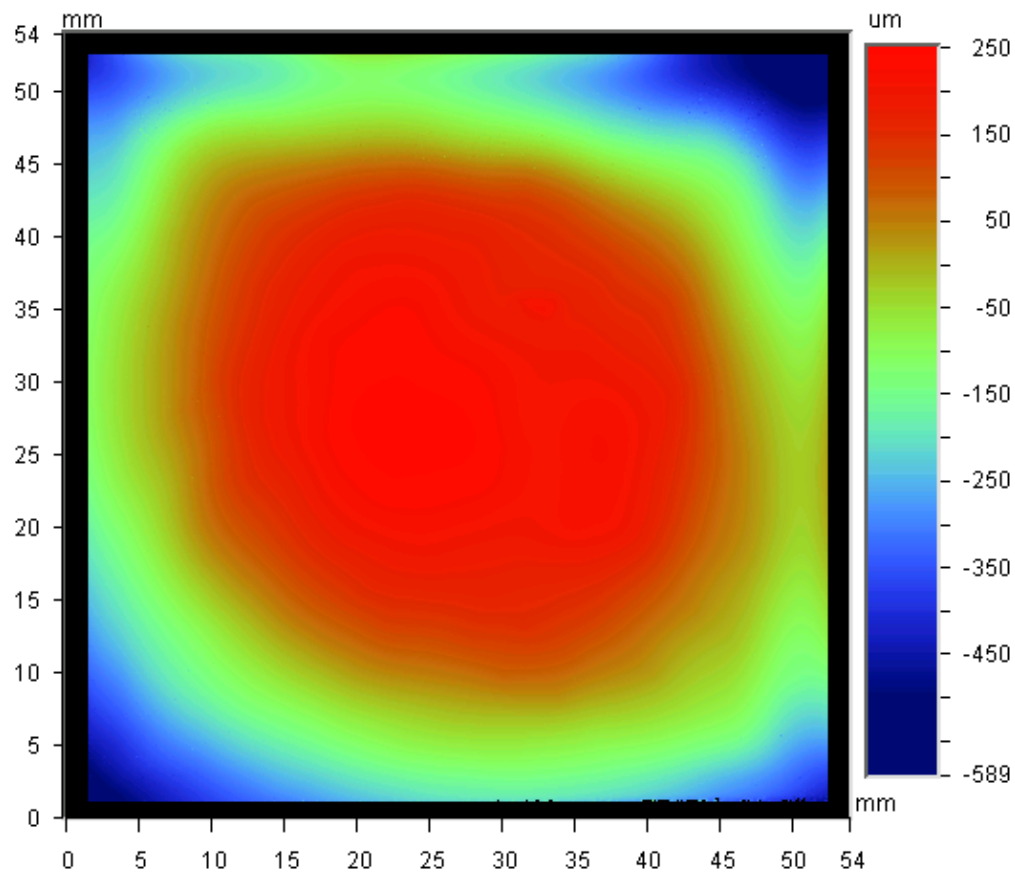
Background

The reliability and durability of materials and components for solid-oxide fuel cells is determined by their state of stress, which consists of the superposition of:

- Residual stresses
- Assembly and Conditioning stresses
- Operational stresses

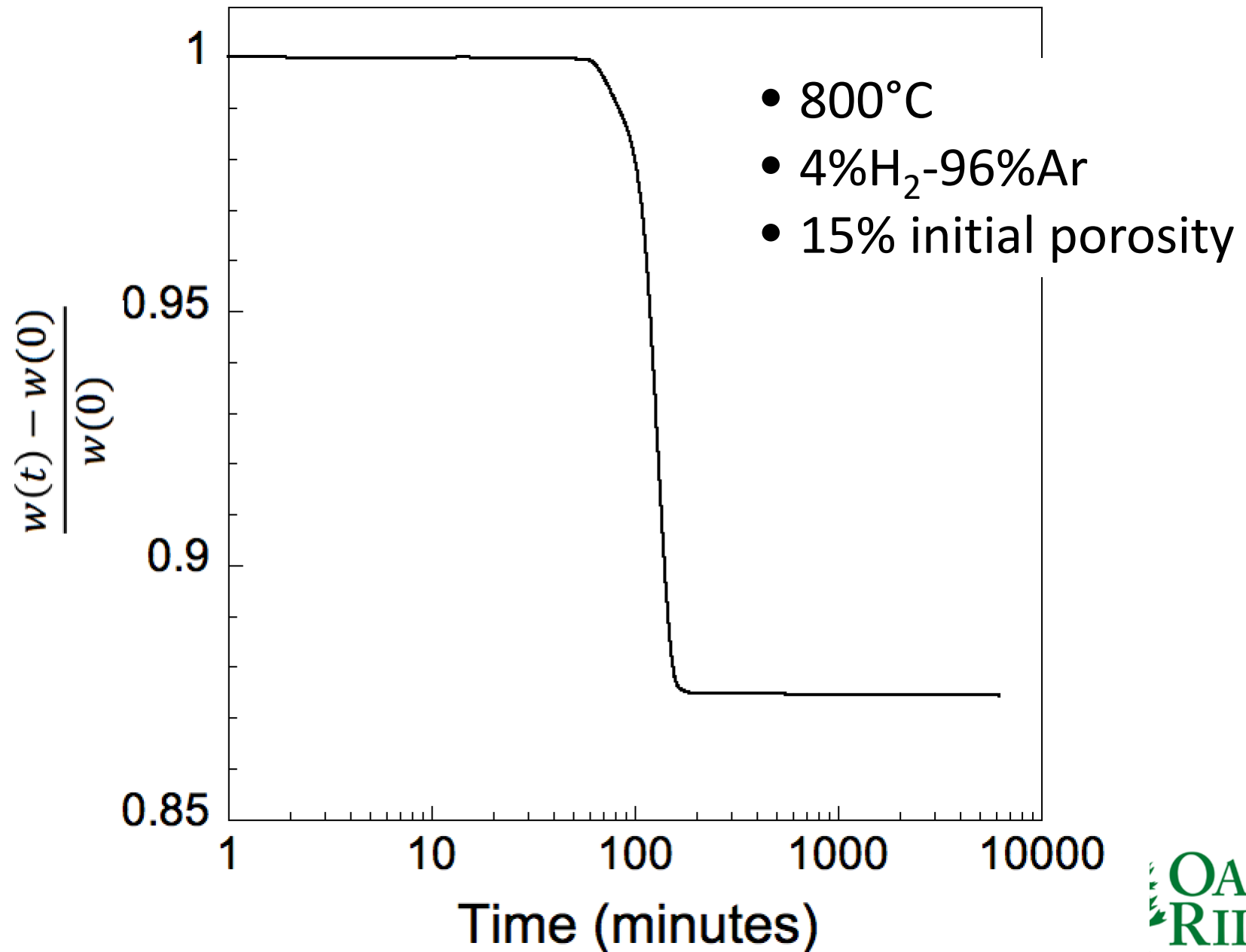
Ni-YSZ exhibits creep deformation at temperatures relevant to the operation of SOFCs

Curvature of NiO-YSZ/YSZ bilayer: optical profilometry



reconstructed object from
profilometric data

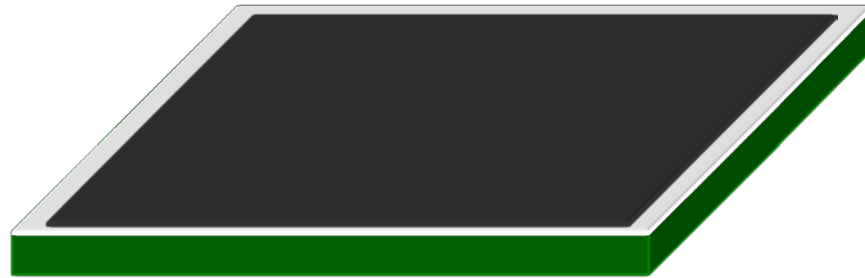
Reduction of NiO-YSZ



Stresses in SOFCs: residual and “reduction” stresses

anode-supported cell

LSM
YSZ
NiO-YSZ



sintering

Stresses in SOFCs: residual and “reduction” stresses

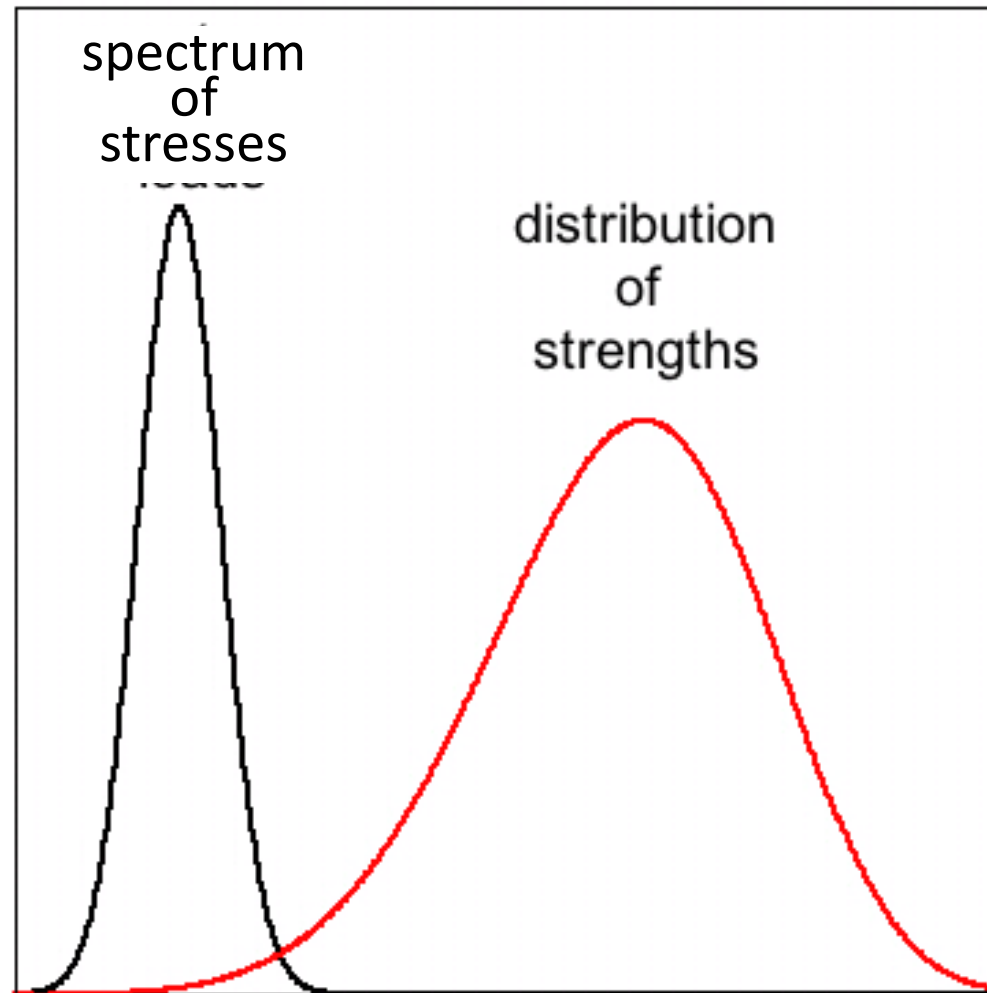
anode-supported cell

LSM
YSZ
Ni-YSZ

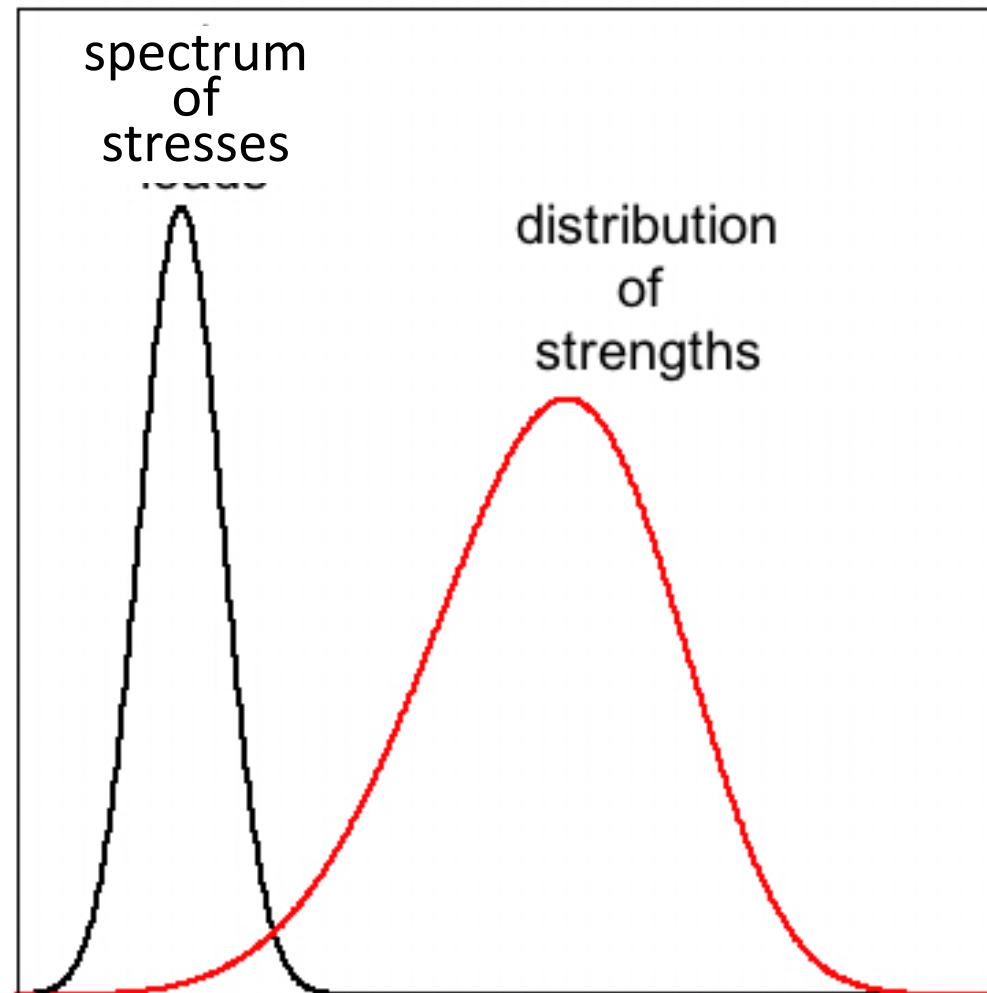


reduction

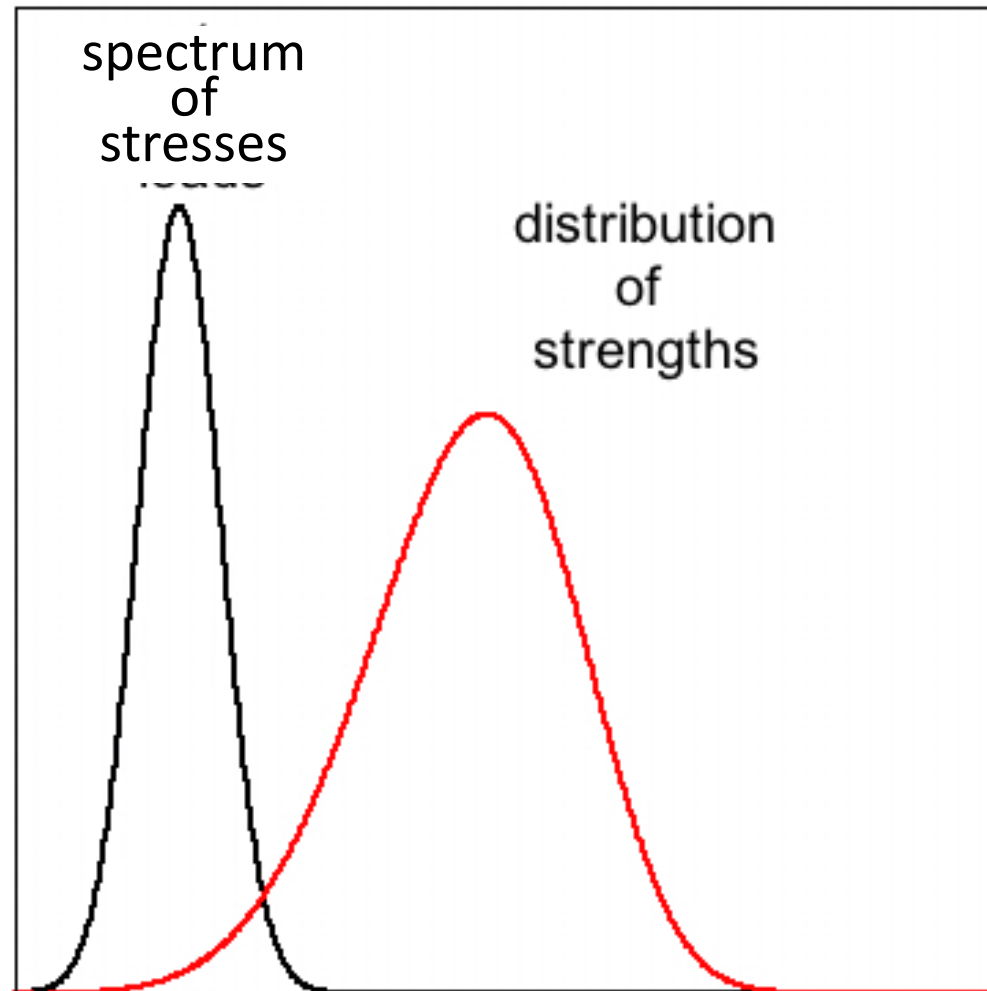
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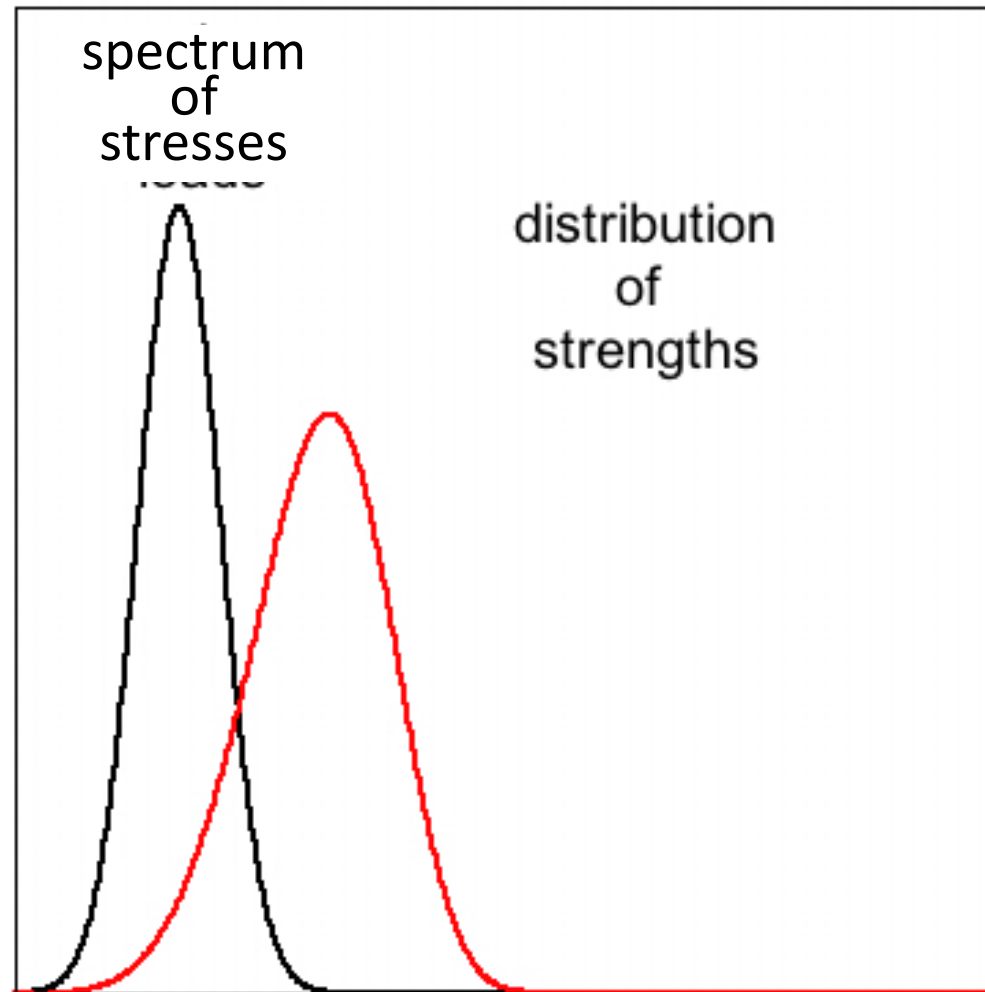
Failure, Reliability and Durability of Systems



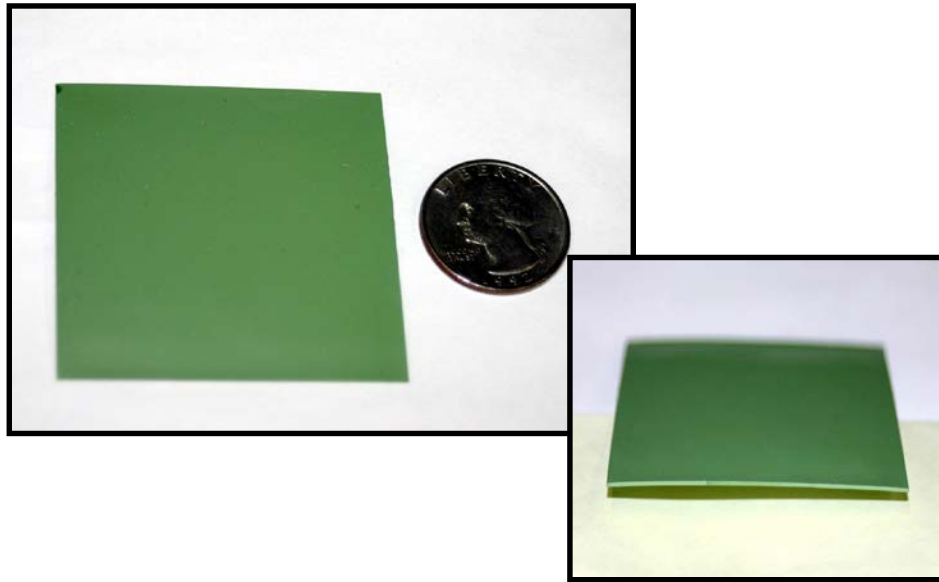
Failure, Reliability and Durability of Systems



Failure, Reliability and Durability of Systems

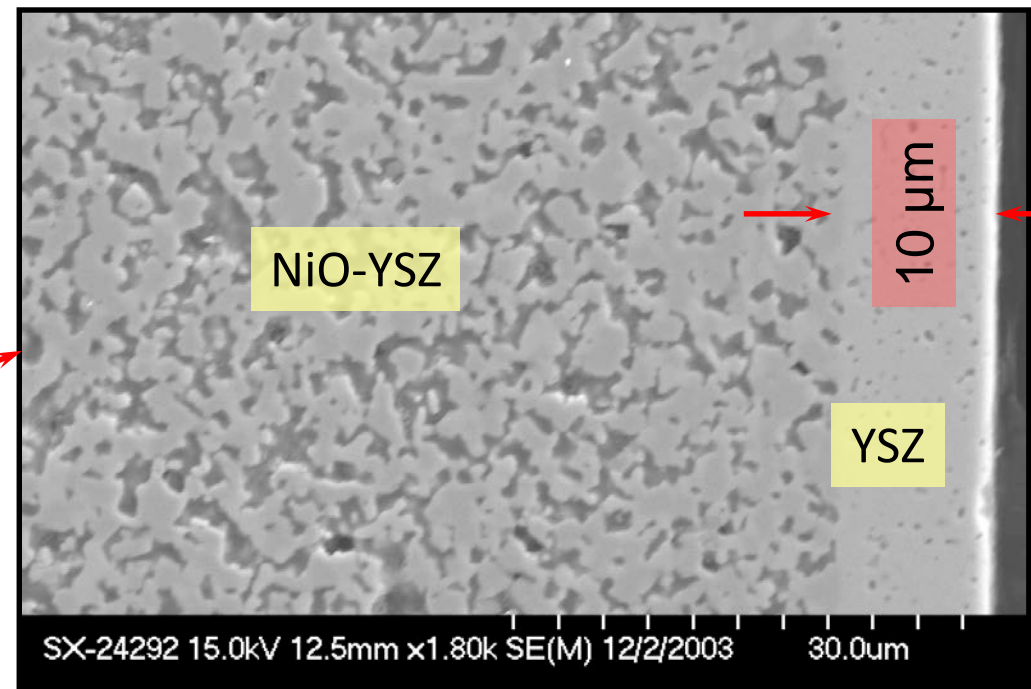
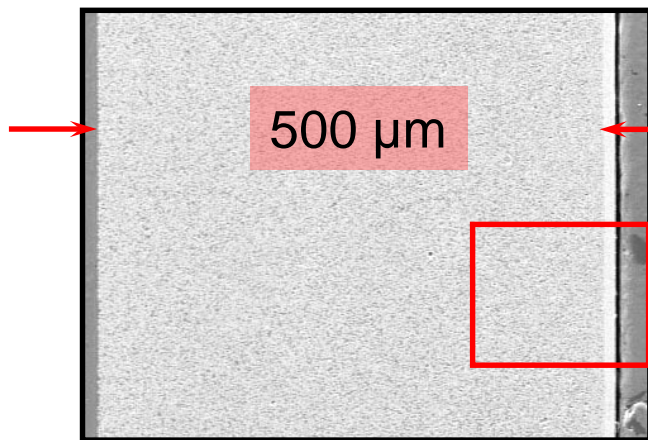


NiO-YSZ/YSZ bilayer

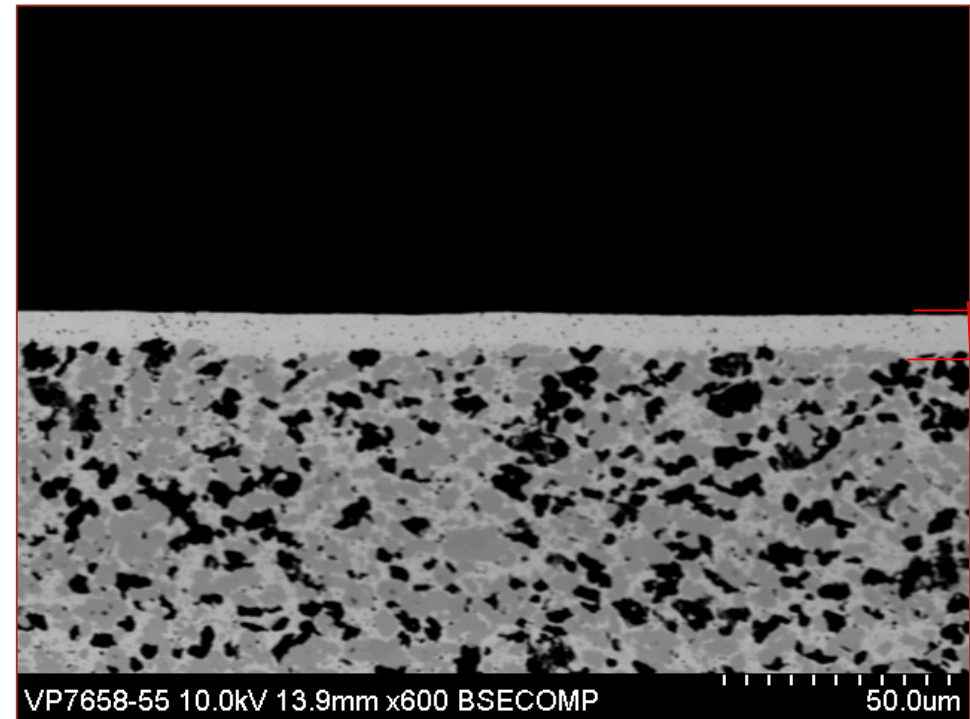
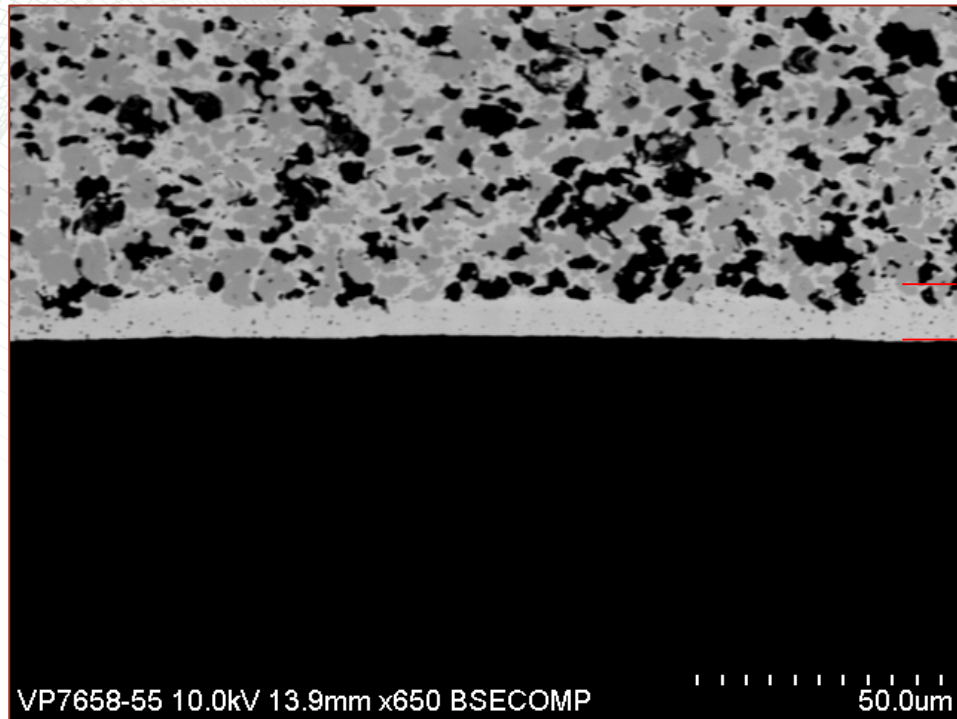


50 mm X 50 mm X 510 μm

Co-sintered in air at 1,400°C for 2 hours



SOFC17S-Dual-3-1

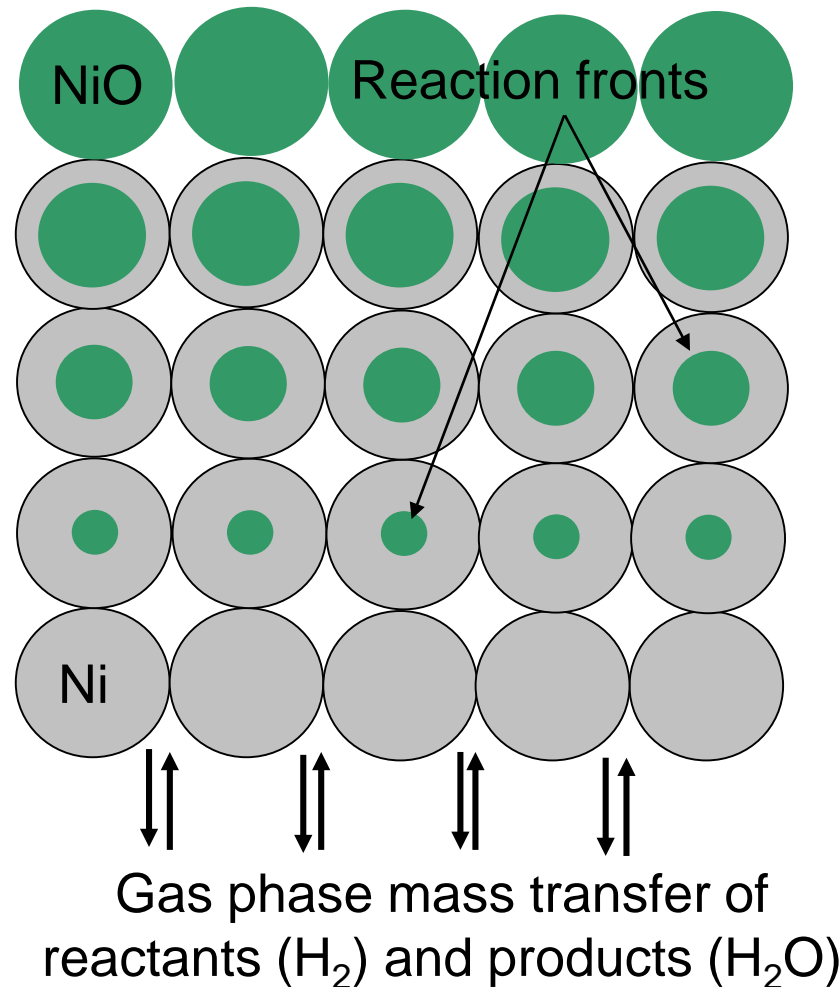


- Average ZrO_2 thickness:
 $9.82 \mu\text{m}$

Elastic Properties of Nickel-Based Anodes for Solid Oxide Fuel Cells as a Function of the Fraction of Reduced NiO

Miladin Radovic* and Edgar Lara-Curzio*

Metals and Ceramics Division, Oak Ridge National Laboratory, Oak Ridge, Tennessee 37831-6069



Porosity in Reduced NiO-YSZ

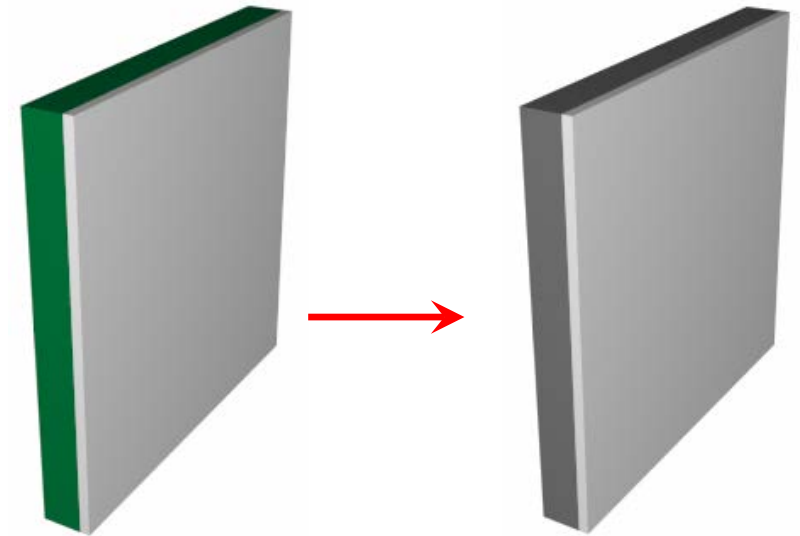
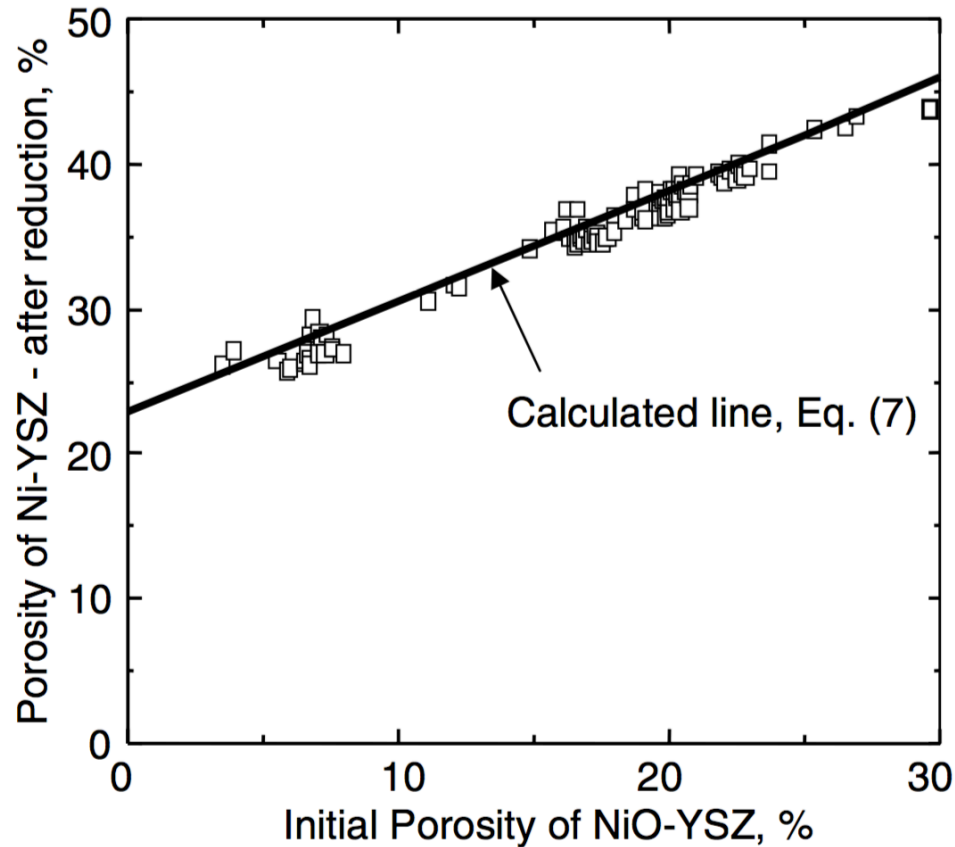


Fig. 1. Relationship between relative porosity of the reduced anode samples and initial porosity of the samples before reduction. Open square symbols represent experimental results determined by alcohol immersion method, while the solid line corresponds to Eq. (7).

Nickel Oxide Reduction by Hydrogen: Kinetics and Structural Transformations

Khachatur V. Manukyan,^{*,†,‡} Arpi G. Avetisyan,[‡] Christopher E. Shuck,[§] Hakob A. Chatilyan,[‡] Sergei Rouvimov,[#] Suren L. Kharatyan,^{‡,⊥} and Alexander S. Mukasyan^{*,§}

[†]Department of Physics, University of Notre Dame, Notre Dame, Indiana 46556, United States

[‡]Laboratory of Kinetics of SHS Processes, Institute of Chemical Physics NAS of Armenia, Yerevan 0014, Armenia

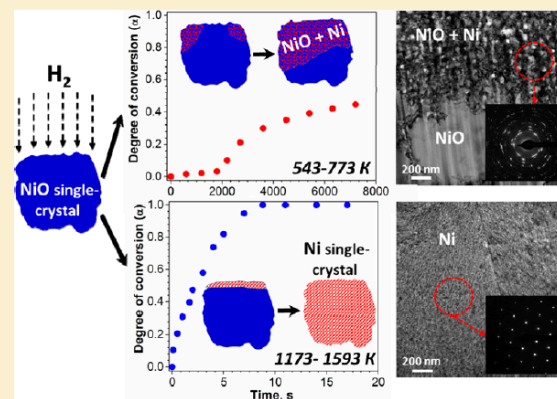
[§]Department of Chemical and Biomolecular Engineering, University of Notre Dame, Notre Dame, Indiana 46556, United States

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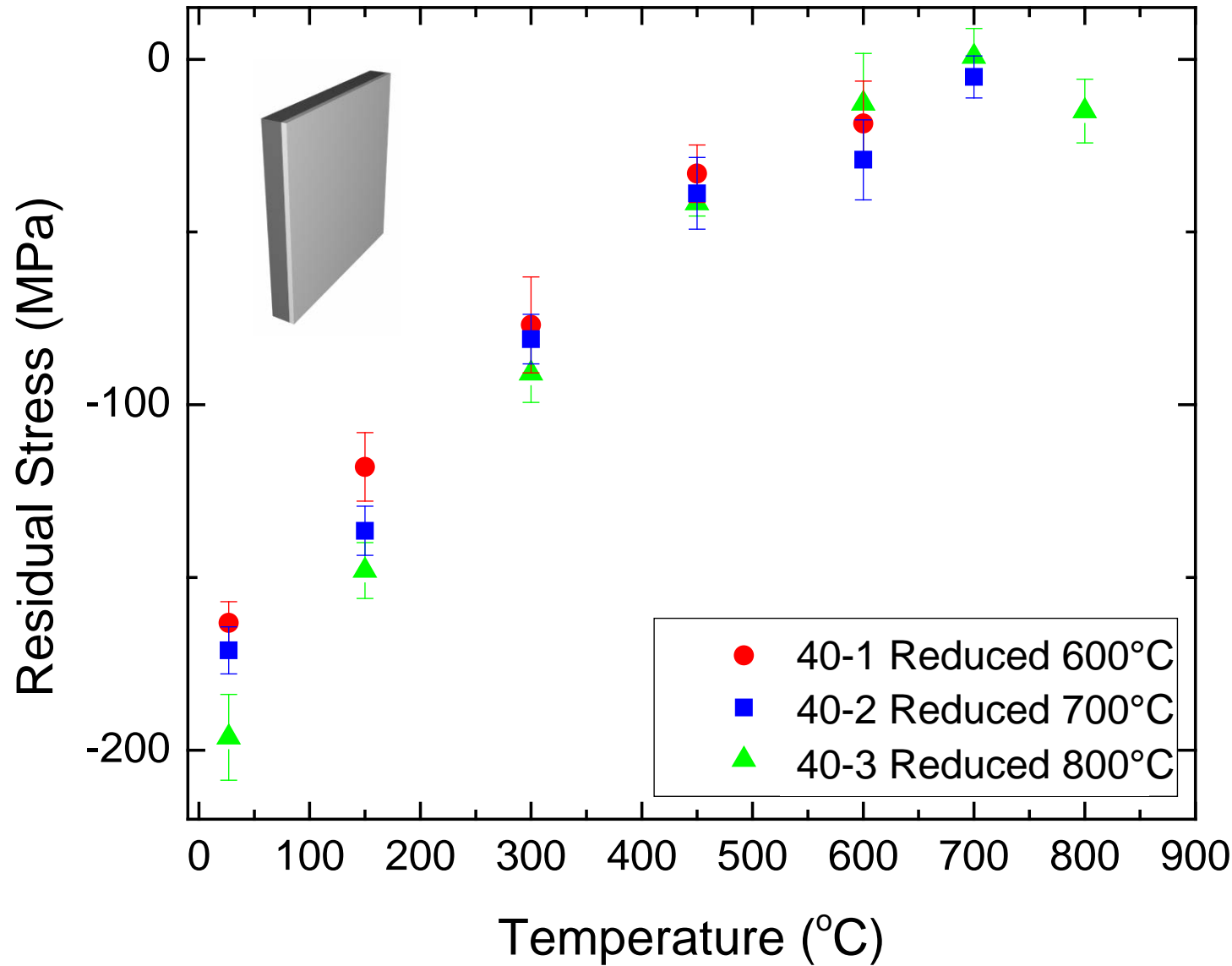
W Web-Enhanced Feature **S** Supporting Information

ABSTRACT: We studied the reduction kinetics of bulk NiO crystals by hydrogen and the corresponding structural transformations in the temperature range of 543–1593 K. A new experimental approach allows us to arrest and quench the reaction at different stages with millisecond time resolution. Two distinctive temperature intervals are found where the reaction kinetics and product microstructures are different. At relatively low temperatures, 543–773 K, the kinetic curves have a sigmoidal shape with long induction times (up to 2000 s) and result in incomplete conversion. Low-temperature reduction forms a complex polycrystalline Ni/NiO porous structure with characteristic pore size on the order of 100 nm. No induction period was observed for the high-temperature conditions (1173–1593 K), and full reduction of NiO to Ni is achieved within seconds. An extremely fine porous metal structure, with pore size under 10 nm, forms during high-temperature reduction by a novel crystal growth mechanism. This consists of the epitaxial-like transformation of micrometer-sized NiO single crystals into single-crystalline Ni without any crystallographic changes, including shape, size, or crystal orientation. The Avrami nucleation model accurately describes the reaction kinetics in both temperature regimes. However, the structural transformations during reduction in both nanolevel and atomic level are very complex, and the mechanism relies on both nucleation and the critical diffusion length for outward diffusion of water molecules.



Reduction of NiO-YSZ

Effect of Reduction Temperature



Porosity

- NiO-YSZ: 40%
- Ni-YSZ: 53%